

1.2 Conducted measurements

RF output power

Mode	DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
a-mode [6Mbps]; 5180MHz	5180.0000	6.5	30.0	6.5	94.223	PASS
a-mode [6Mbps]; 5200MHz	5200.0000	6.4	30.0	6.4	94.351	PASS
a-mode [6Mbps]; 5240MHz	5240.0000	7.4	30.0	7.4	94.281	PASS
a-mode [6Mbps]; 5745MHz	5745.0000	3.5	30.0	3.5	94.306	PASS
a-mode [6Mbps]; 5785MHz	5785.0000	4.0	30.0	4.0	94.309	PASS
a-mode [6Mbps]; 5825MHz	5825.0000	2.0	30.0	2.0	94.320	PASS
a-mode [9Mbps]; 5180MHz	5180.0000	8.3	30.0	8.3	91.931	PASS
a-mode [9Mbps]; 5200MHz	5200.0000	7.9	30.0	7.9	91.748	PASS
a-mode [9Mbps]; 5240MHz	5240.0000	8.7	30.0	8.7	91.928	PASS
a-mode [9Mbps]; 5745MHz	5745.0000	3.4	30.0	3.4	91.902	PASS
a-mode [9Mbps]; 5785MHz	5785.0000	3.8	30.0	3.8	91.831	PASS
a-mode [9Mbps]; 5825MHz	5825.0000	3.7	30.0	3.7	91.720	PASS
a-mode [12Mbps]; 5180MHz	5180.0000	8.3	30.0	8.3	89.521	PASS
a-mode [12Mbps]; 5200MHz	5200.0000	7.9	30.0	7.9	89.439	PASS
a-mode [12Mbps]; 5240MHz	5240.0000	8.7	30.0	8.7	89.439	PASS
a-mode [12Mbps]; 5745MHz	5745.0000	3.4	30.0	3.4	89.538	PASS
a-mode [12Mbps]; 5785MHz	5785.0000	3.8	30.0	3.8	89.484	PASS
a-mode [12Mbps]; 5825MHz	5825.0000	3.7	30.0	3.7	89.393	PASS
a-mode [18Mbps]; 5180MHz	5180.0000	8.5	30.0	8.5	85.304	PASS
a-mode [18Mbps]; 5200MHz	5200.0000	8.1	30.0	8.1	85.171	PASS
a-mode [18Mbps]; 5240MHz	5240.0000	8.9	30.0	8.9	85.166	PASS
a-mode [18Mbps]; 5745MHz	5745.0000	3.5	30.0	3.5	85.361	PASS
a-mode [18Mbps]; 5785MHz	5785.0000	4.0	30.0	4.0	85.251	PASS
a-mode [18Mbps]; 5825MHz	5825.0000	3.8	30.0	3.8	85.337	PASS
a-mode [24Mbps]; 5180MHz	5180.0000	8.7	30.0	8.7	81.427	PASS
a-mode [24Mbps]; 5200MHz	5200.0000	8.3	30.0	8.3	81.444	PASS
a-mode [24Mbps]; 5240MHz	5240.0000	9.1	30.0	9.1	81.334	PASS
a-mode [24Mbps]; 5745MHz	5745.0000	3.9	30.0	3.9	81.255	PASS
a-mode [24Mbps]; 5785MHz	5785.0000	4.3	30.0	4.3	81.440	PASS
a-mode [24Mbps]; 5825MHz	5825.0000	4.2	30.0	4.2	81.228	PASS
a-mode [36Mbps]; 5180MHz	5180.0000	8.7	30.0	8.7	74.863	PASS
a-mode [36Mbps]; 5200MHz	5200.0000	8.3	30.0	8.3	74.761	PASS
a-mode [36Mbps]; 5240MHz	5240.0000	9.1	30.0	9.1	74.779	PASS
a-mode [36Mbps]; 5745MHz	5745.0000	3.8	30.0	3.8	74.991	PASS
a-mode [36Mbps]; 5785MHz	5785.0000	4.2	30.0	4.2	75.030	PASS
a-mode [36Mbps]; 5825MHz	5825.0000	4.1	30.0	4.1	74.966	PASS
a-mode [48Mbps]; 5180MHz	5180.0000	8.8	30.0	8.8	69.578	PASS
a-mode [48Mbps]; 5200MHz	5200.0000	8.4	30.0	8.4	69.495	PASS
a-mode [48Mbps]; 5240MHz	5240.0000	9.1	30.0	9.1	69.440	PASS
a-mode [48Mbps]; 5745MHz	5745.0000	3.9	30.0	3.9	69.657	PASS
a-mode [48Mbps]; 5785MHz	5785.0000	4.3	30.0	4.3	69.531	PASS
a-mode [48Mbps]; 5825MHz	5825.0000	4.1	30.0	4.1	69.582	PASS
a-mode [54Mbps]; 5180MHz	5180.0000	8.7	30.0	8.7	67.225	PASS
a-mode [54Mbps]; 5200MHz	5200.0000	8.3	30.0	8.3	67.360	PASS
a-mode [54Mbps]; 5240MHz	5240.0000	9.1	30.0	9.1	67.352	PASS
a-mode [54Mbps]; 5745MHz	5745.0000	3.8	30.0	3.8	67.217	PASS
a-mode [54Mbps]; 5785MHz	5785.0000	4.2	30.0	4.2	67.293	PASS
a-mode [54Mbps]; 5825MHz	5825.0000	4.1	30.0	4.1	67.157	PASS

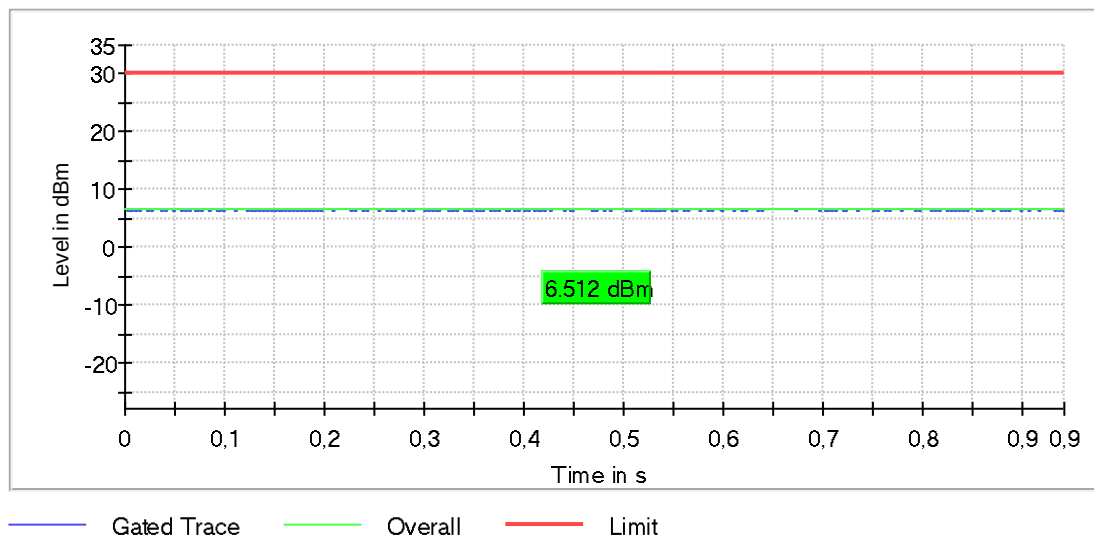
RF output power (5180 MHz; a-mode [6Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	6.5	30.0	6.5	94.223	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

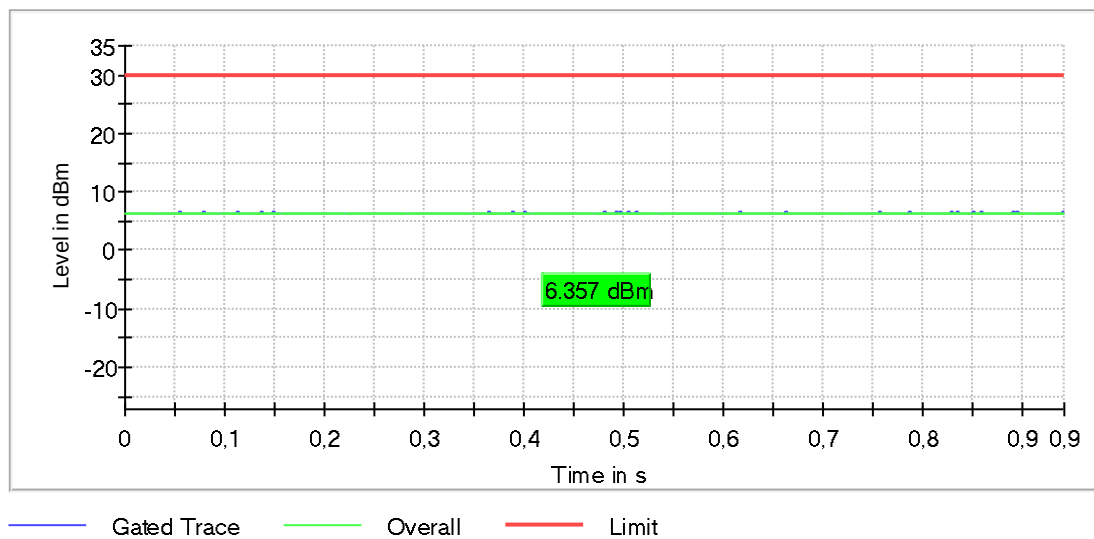
RF output power (5200 MHz; a-mode [6Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	6.4	30.0	6.4	94.351	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

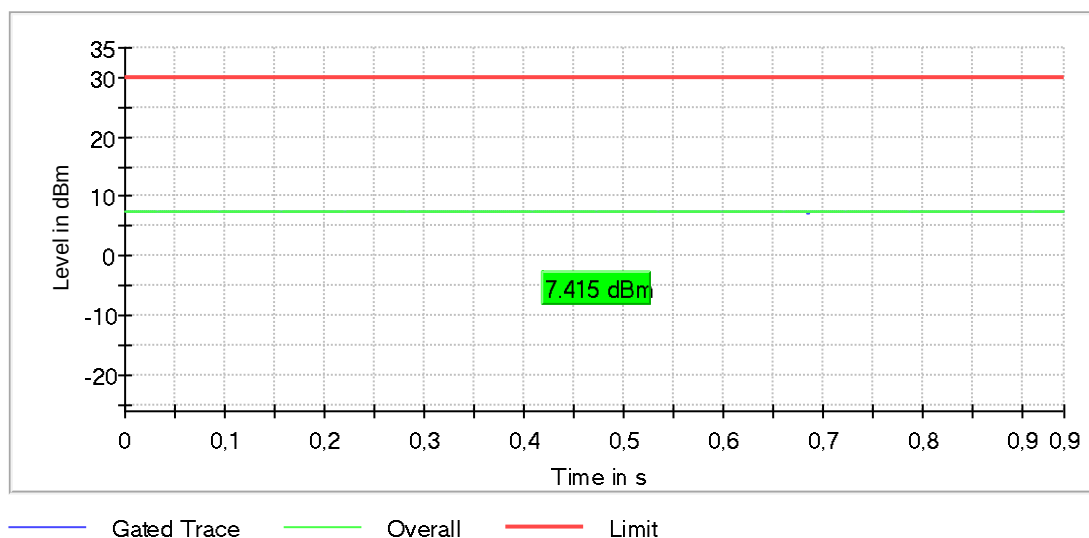
RF output power (5240 MHz; a-mode [6Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	7.4	30.0	7.4	94.281	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

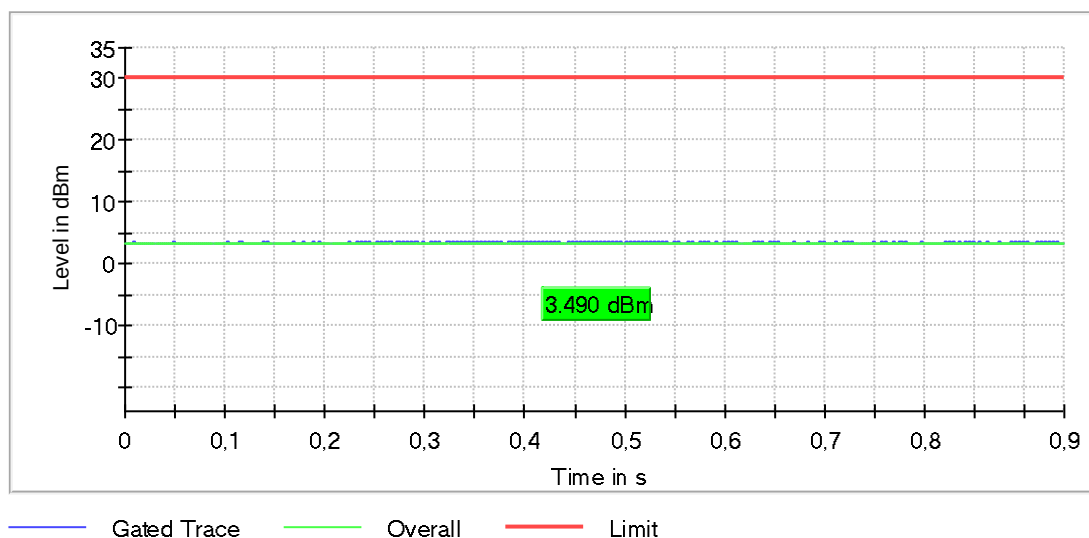
RF output power (5745 MHz; a-mode [6Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.5	30.0	3.5	94.306	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

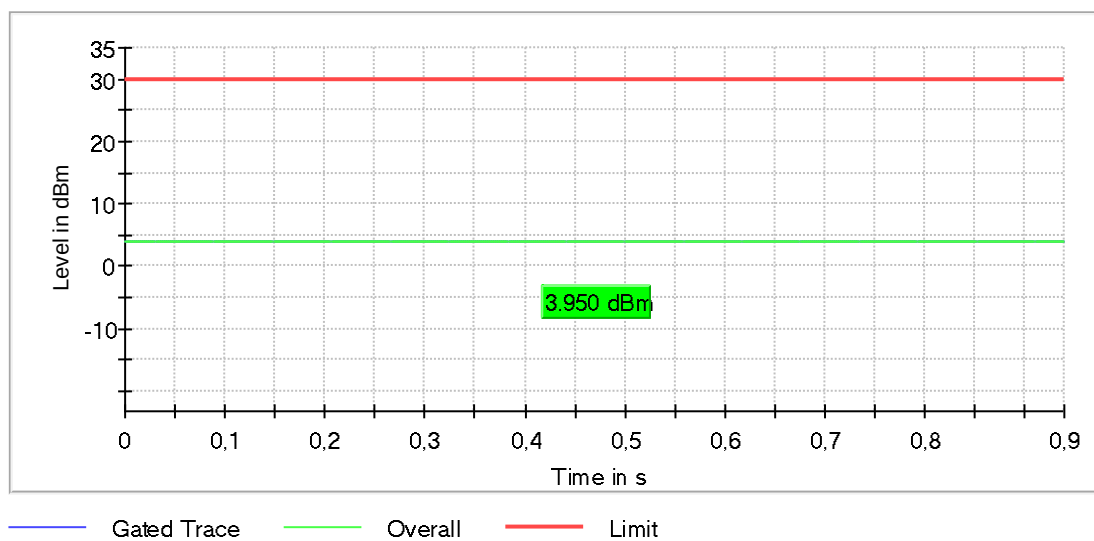
RF output power (5785 MHz; a-mode [6Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.0	30.0	4.0	94.309	PASS

Gated Trace



OSP PowerMeter settings

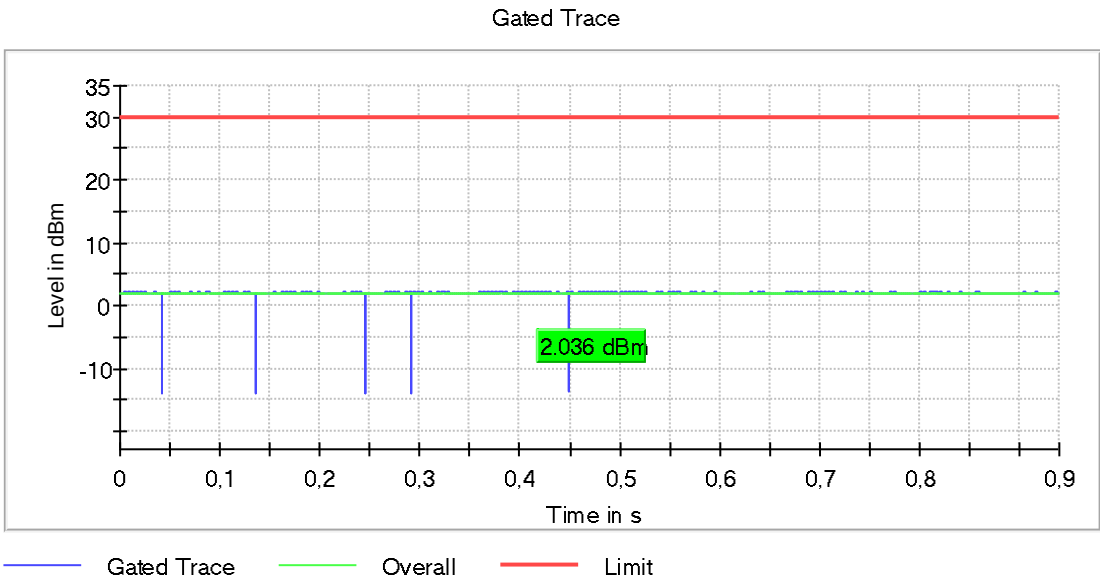
Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

RF output power (5825 MHz; a-mode [6Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	2.0	30.0	2.0	94.320	PASS



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

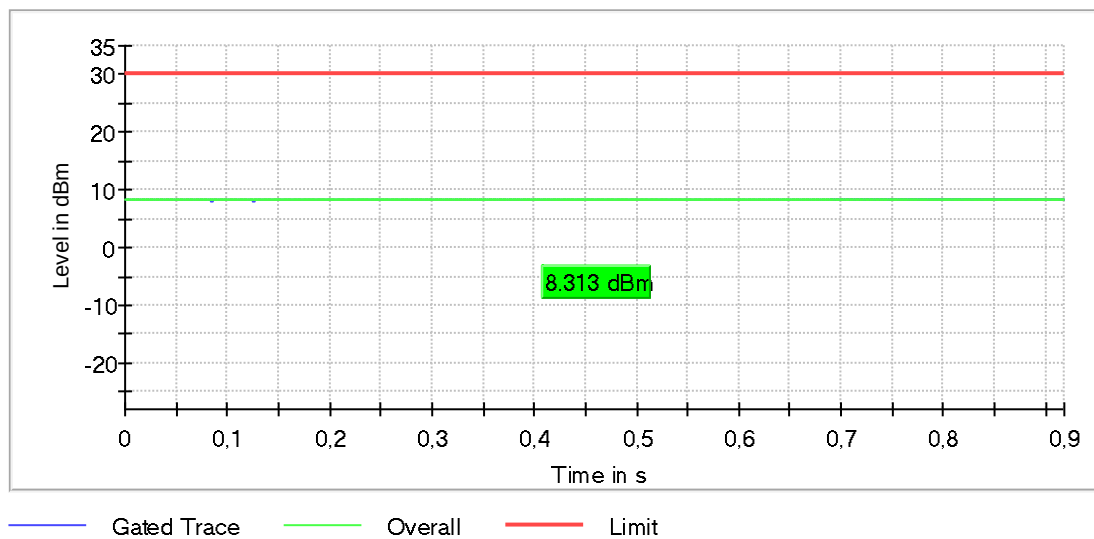
RF output power (5180 MHz; a-mode [9Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.3	30.0	8.3	91.931	PASS

Gated Trace



OSP PowerMeter settings

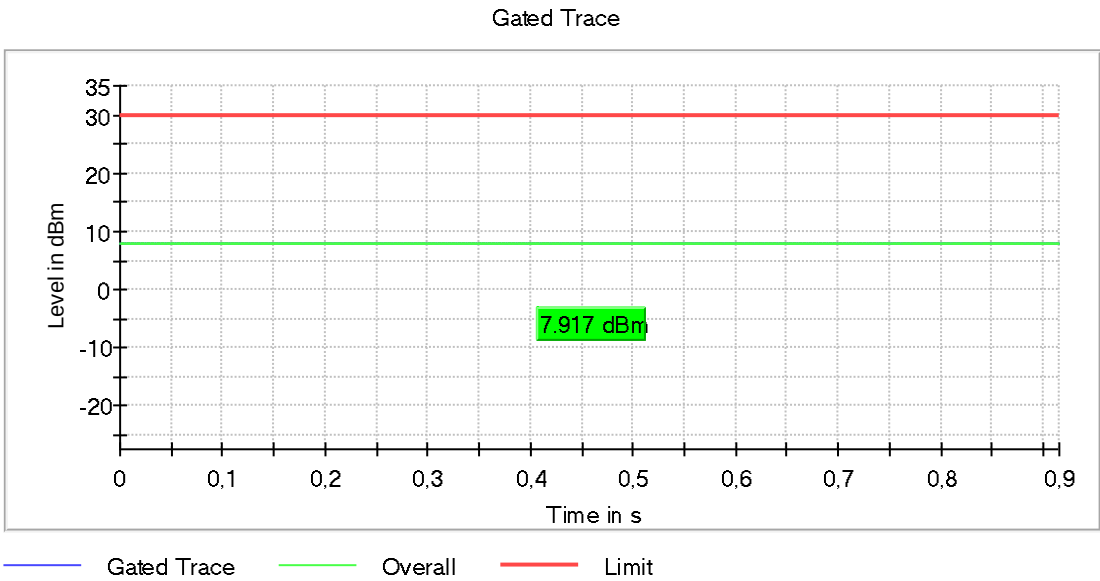
Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

RF output power (5200 MHz; a-mode [9Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	7.9	30.0	7.9	91.748	PASS



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

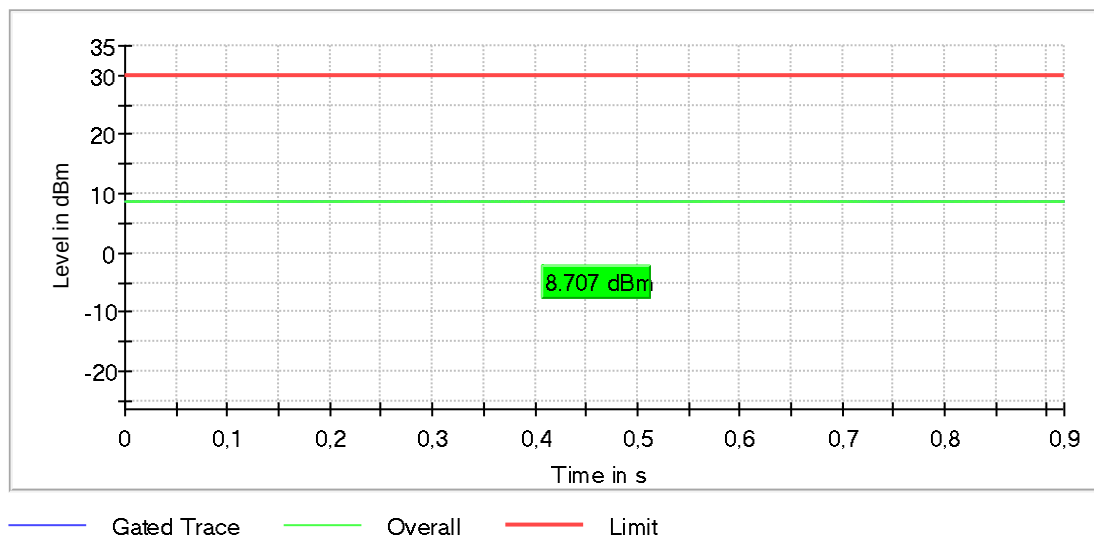
RF output power (5240 MHz; a-mode [9Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	8.7	30.0	8.7	91.928	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

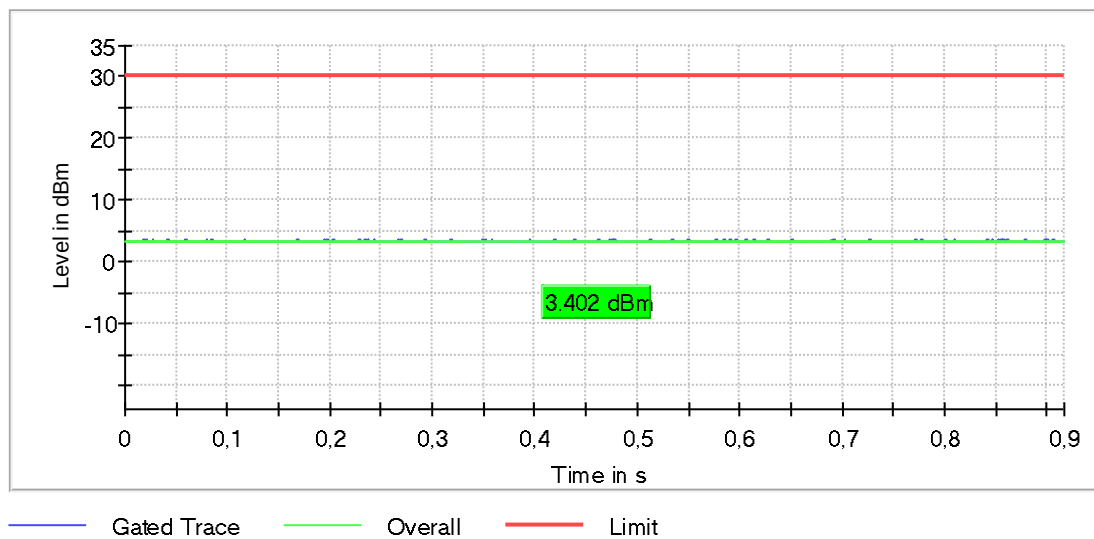
RF output power (5745 MHz; a-mode [9Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.4	30.0	3.4	91.902	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

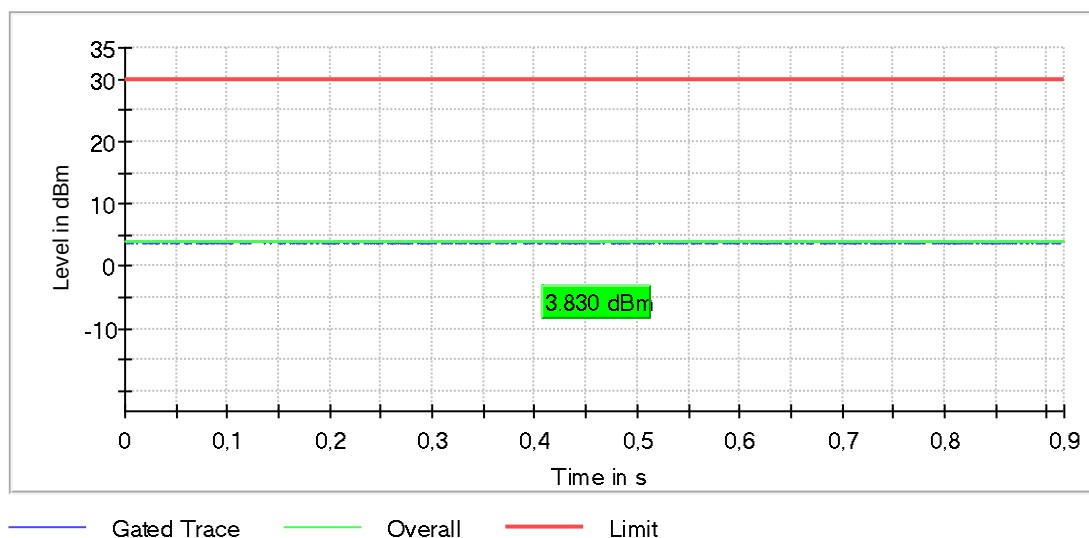
RF output power (5785 MHz; a-mode [9Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	3.8	30.0	3.8	91.831	PASS

Gated Trace



OSP PowerMeter settings

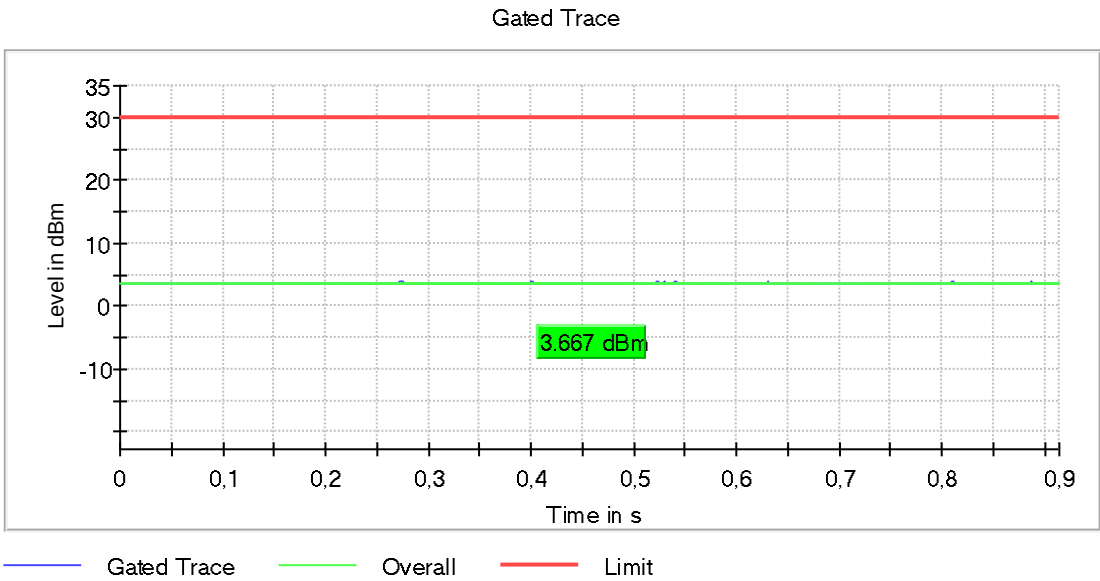
Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

RF output power (5825 MHz; a-mode [9Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	3.7	30.0	3.7	91.720	PASS



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

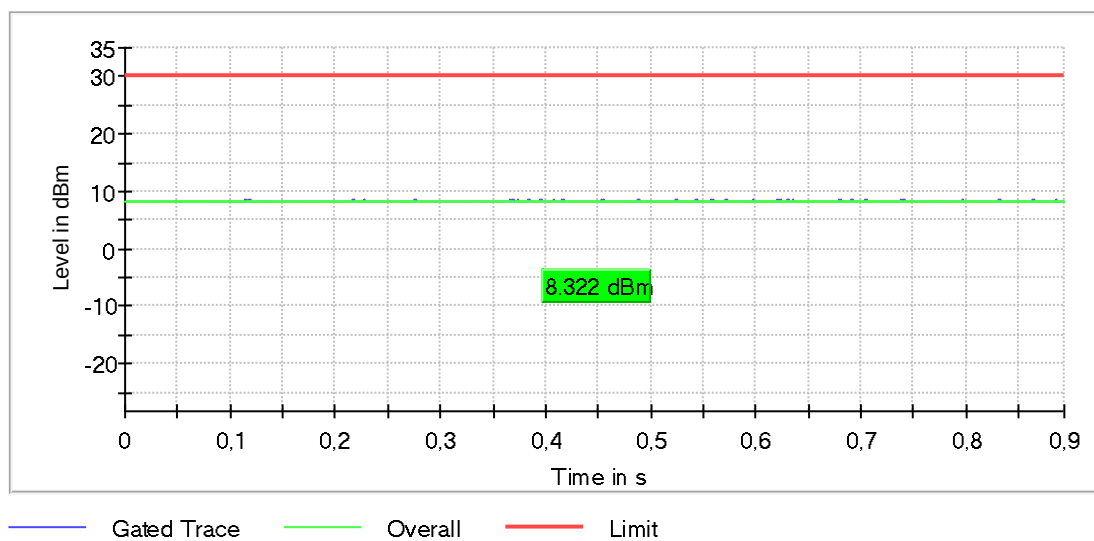
RF output power (5180 MHz; a-mode [12Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.3	30.0	8.3	89.521	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

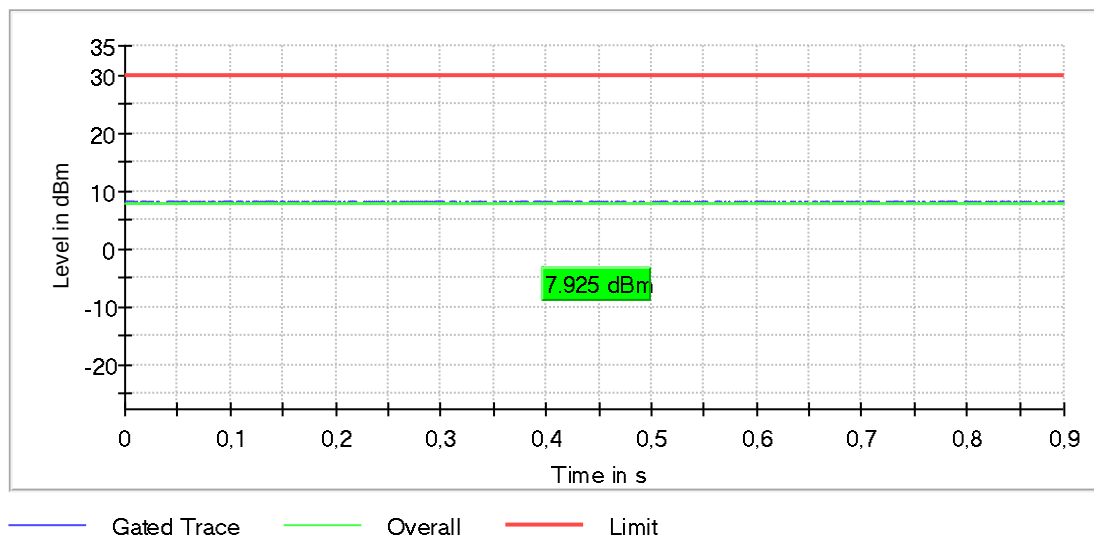
RF output power (5200 MHz; a-mode [12Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	7.9	30.0	7.9	89.439	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

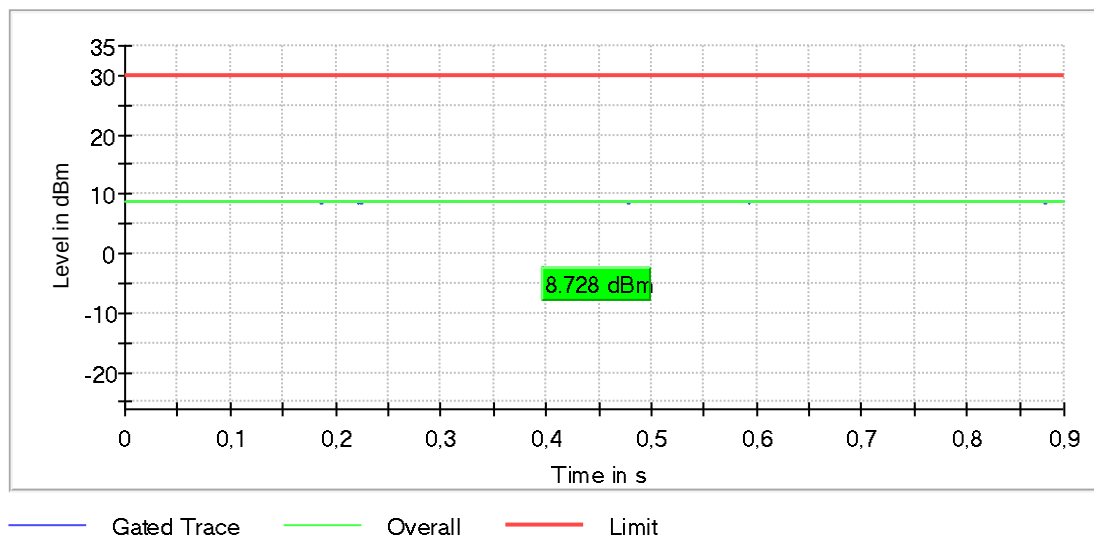
RF output power (5240 MHz; a-mode [12Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	8.7	30.0	8.7	89.439	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

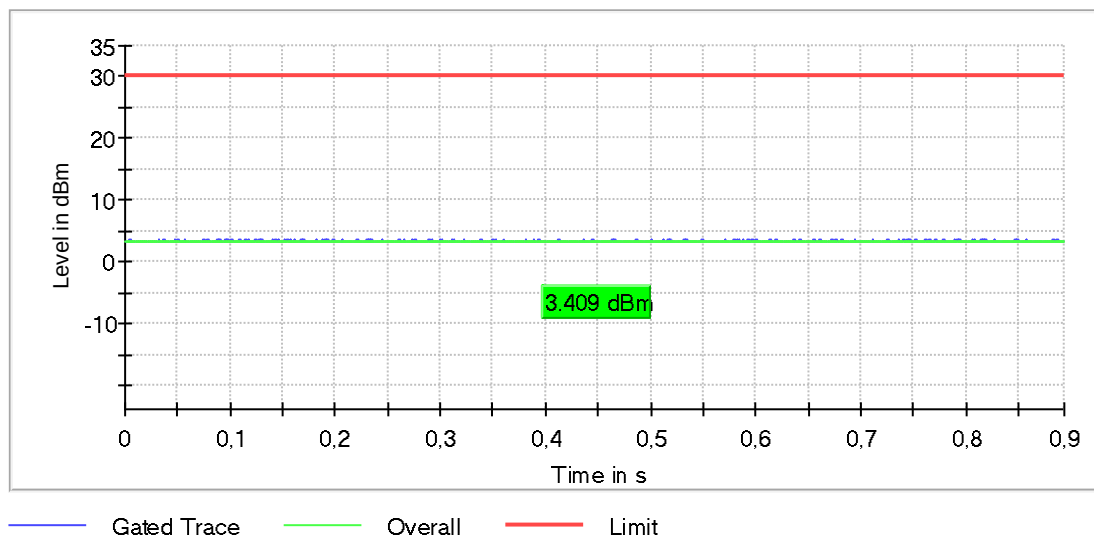
RF output power (5745 MHz; a-mode [12Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.4	30.0	3.4	89.538	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

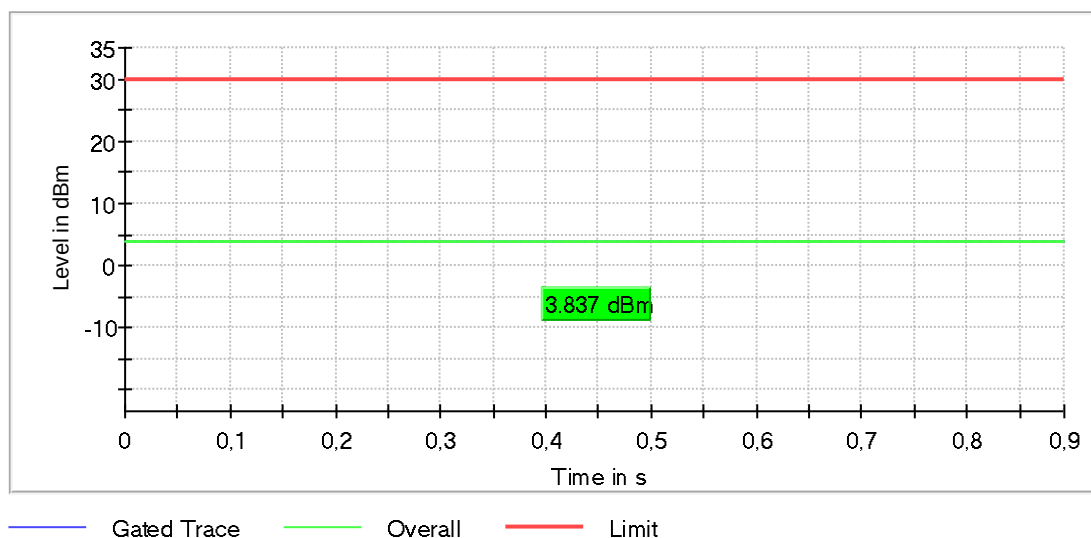
RF output power (5785 MHz; a-mode [12Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	3.8	30.0	3.8	89.484	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

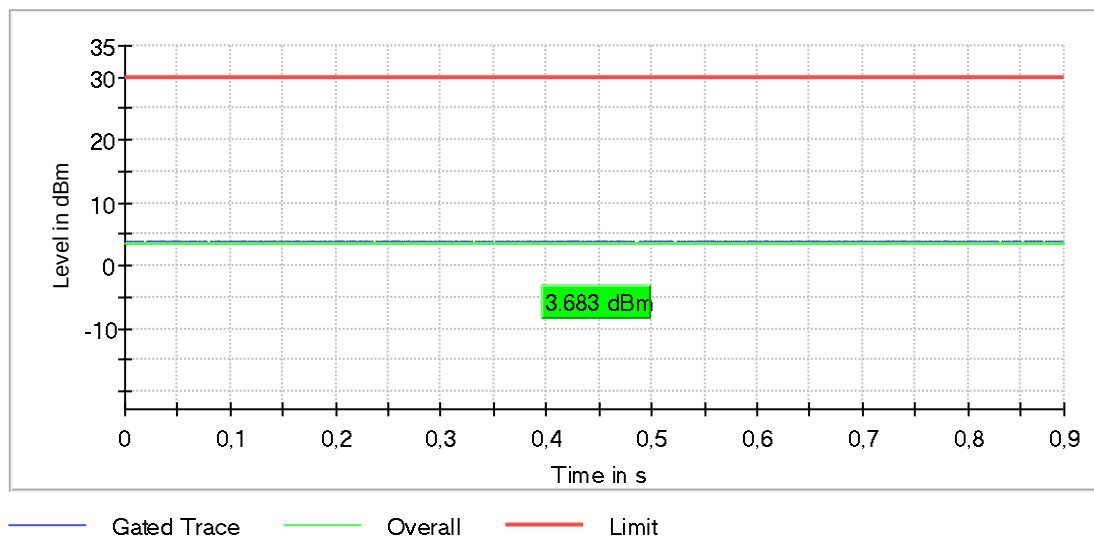
RF output power (5825 MHz; a-mode [12Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	3.7	30.0	3.7	89.393	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

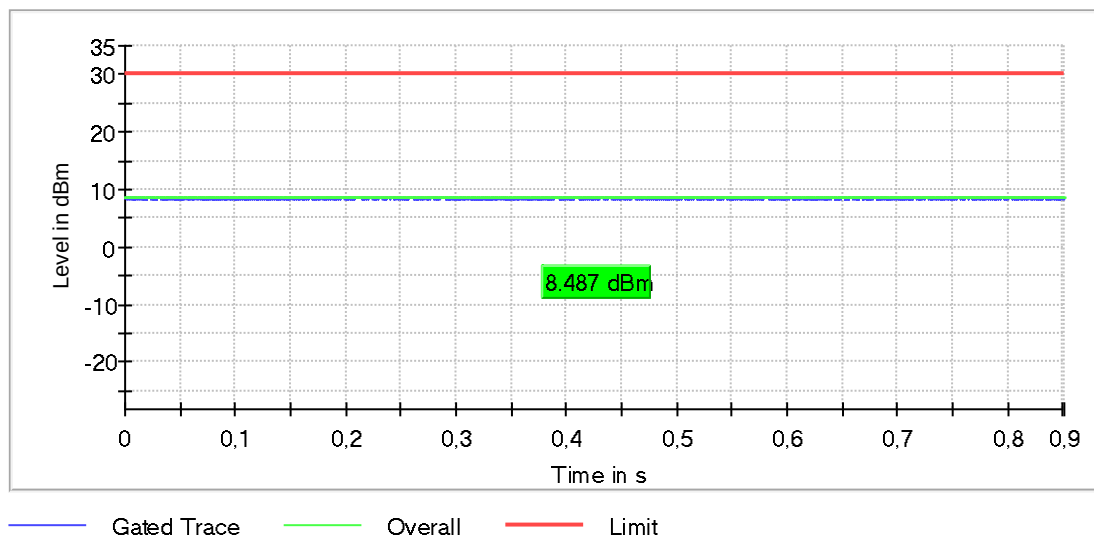
RF output power (5180 MHz; a-mode [18Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.5	30.0	8.5	85.304	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

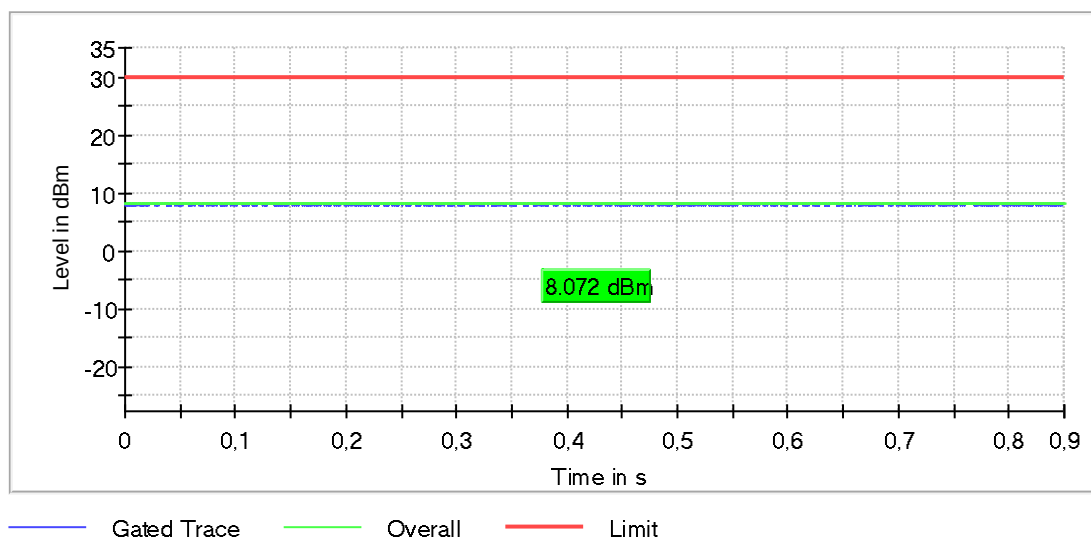
RF output power (5200 MHz; a-mode [18Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.1	30.0	8.1	85.171	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

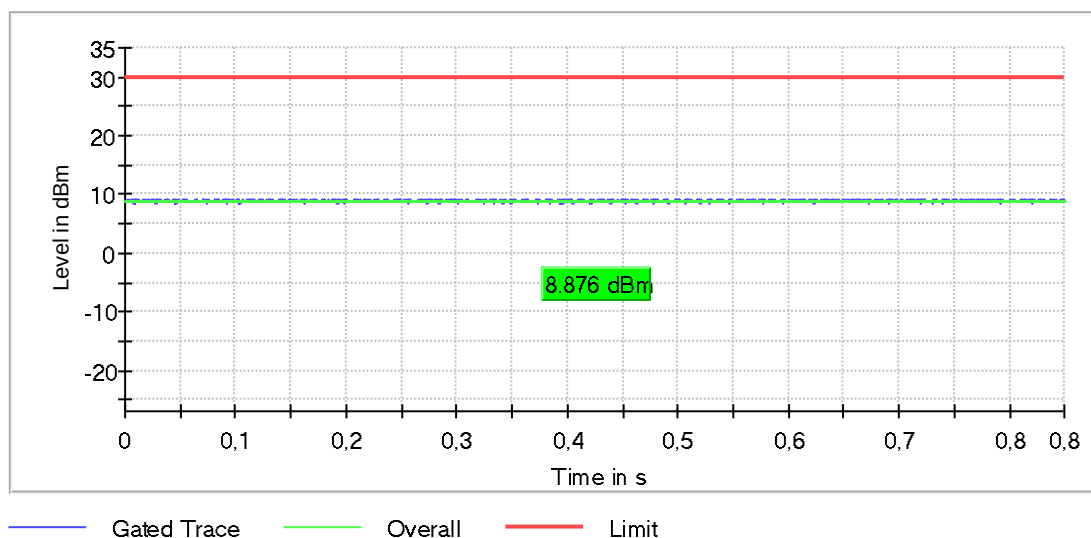
RF output power (5240 MHz; a-mode [18Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	8.9	30.0	8.9	85.166	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

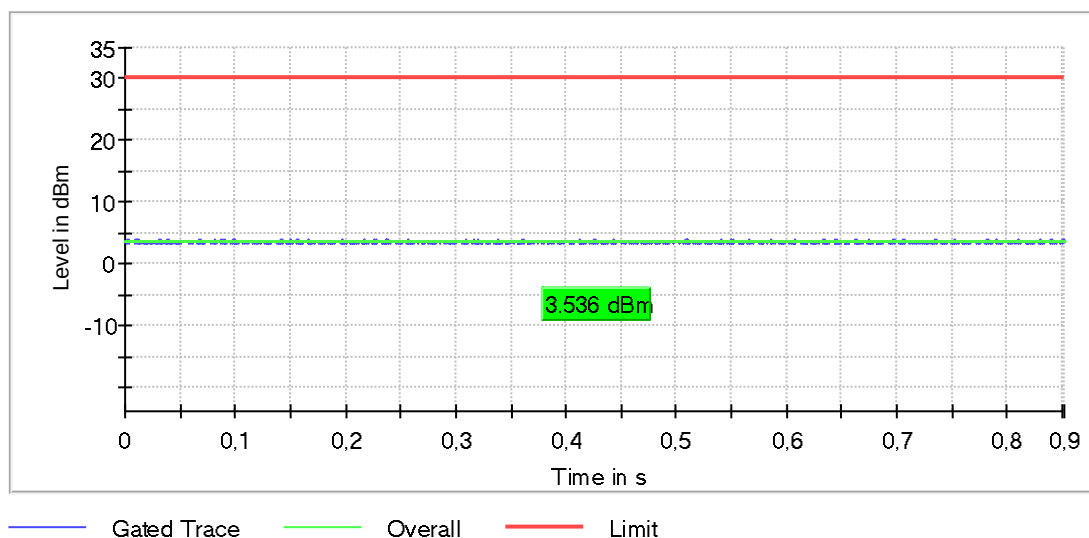
RF output power (5745 MHz; a-mode [18Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.5	30.0	3.5	85.361	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

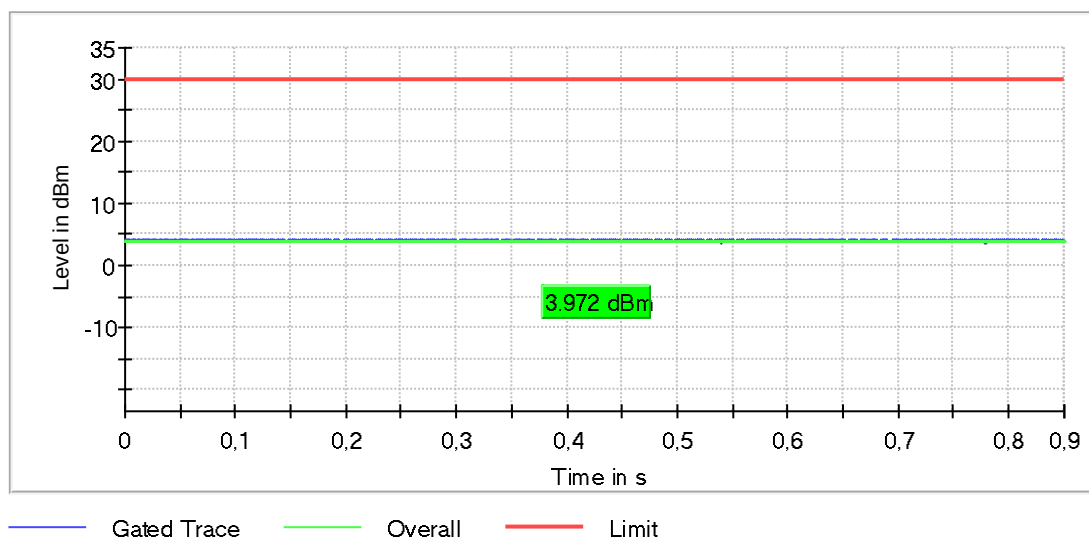
RF output power (5785 MHz; a-mode [18Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.0	30.0	4.0	85.251	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

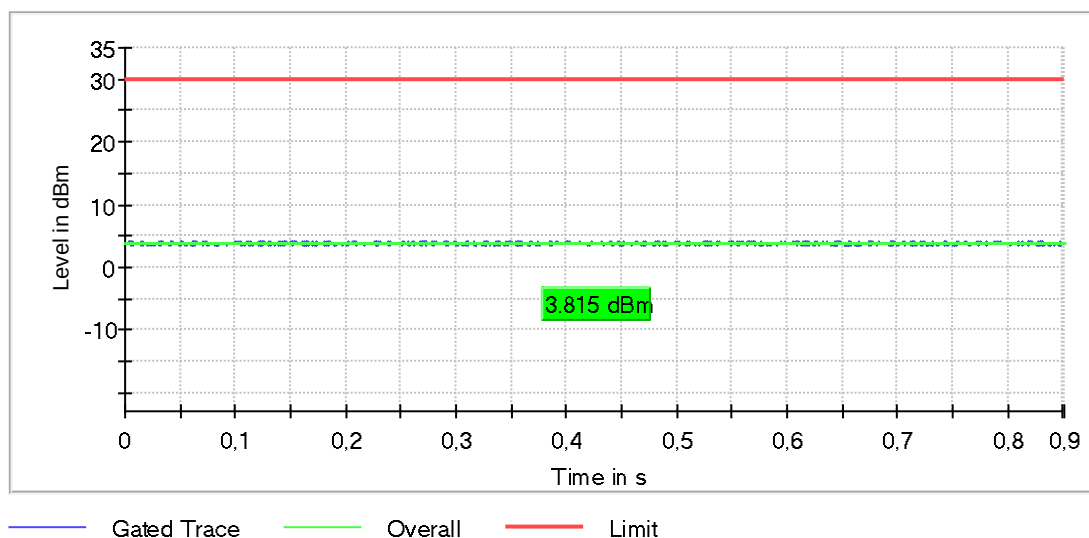
RF output power (5825 MHz; a-mode [18Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	3.8	30.0	3.8	85.337	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

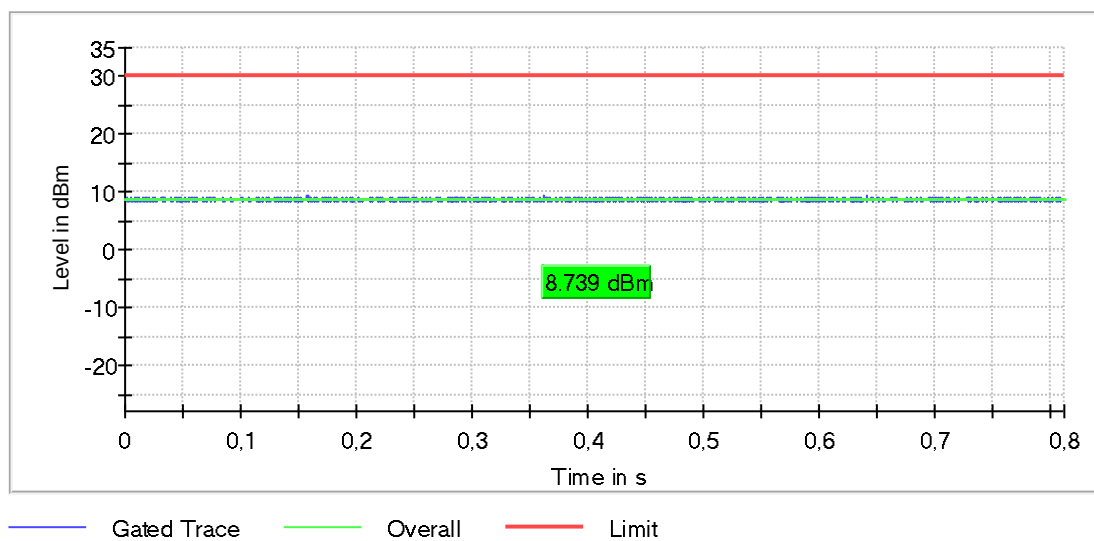
RF output power (5180 MHz; a-mode [24Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.7	30.0	8.7	81.427	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

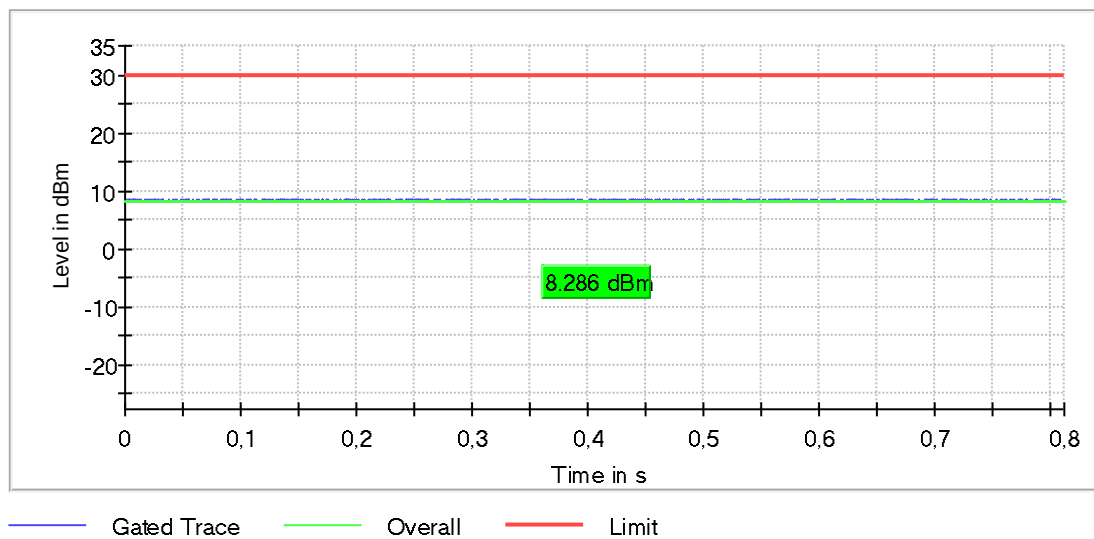
RF output power (5200 MHz; a-mode [24Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.3	30.0	8.3	81.444	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

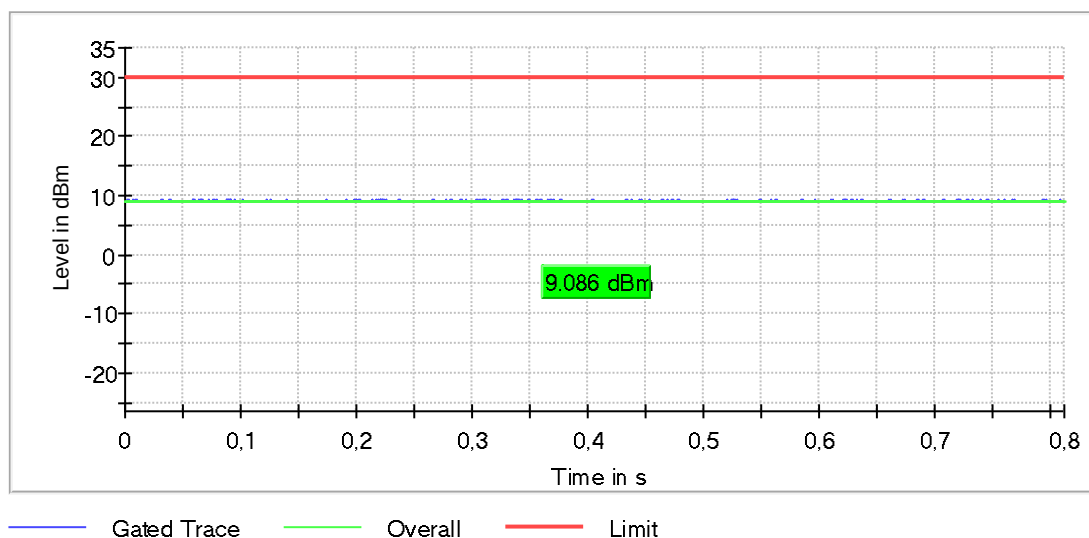
RF output power (5240 MHz; a-mode [24Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.1	30.0	9.1	81.334	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

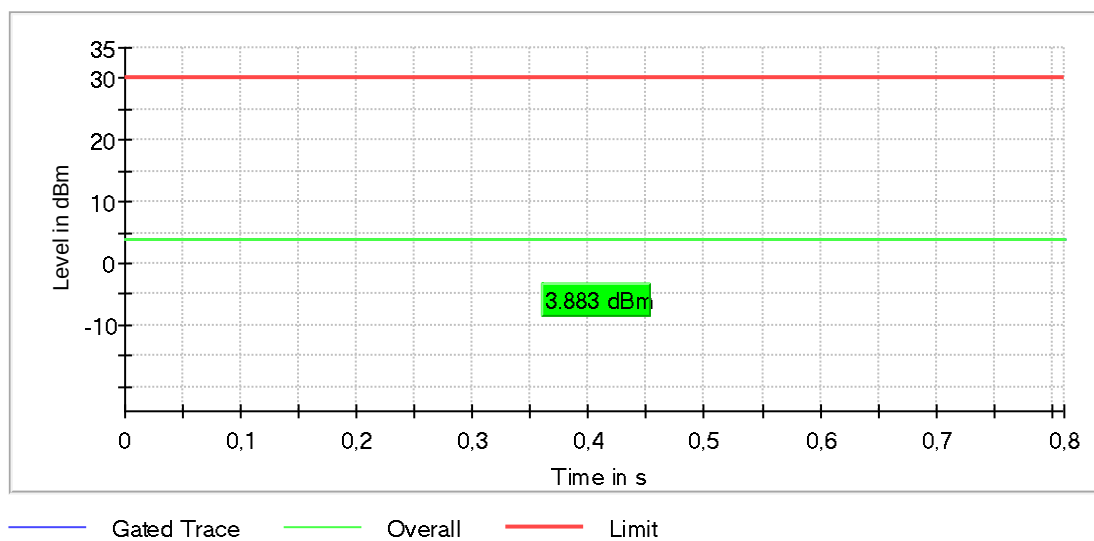
RF output power (5745 MHz; a-mode [24Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.9	30.0	3.9	81.255	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

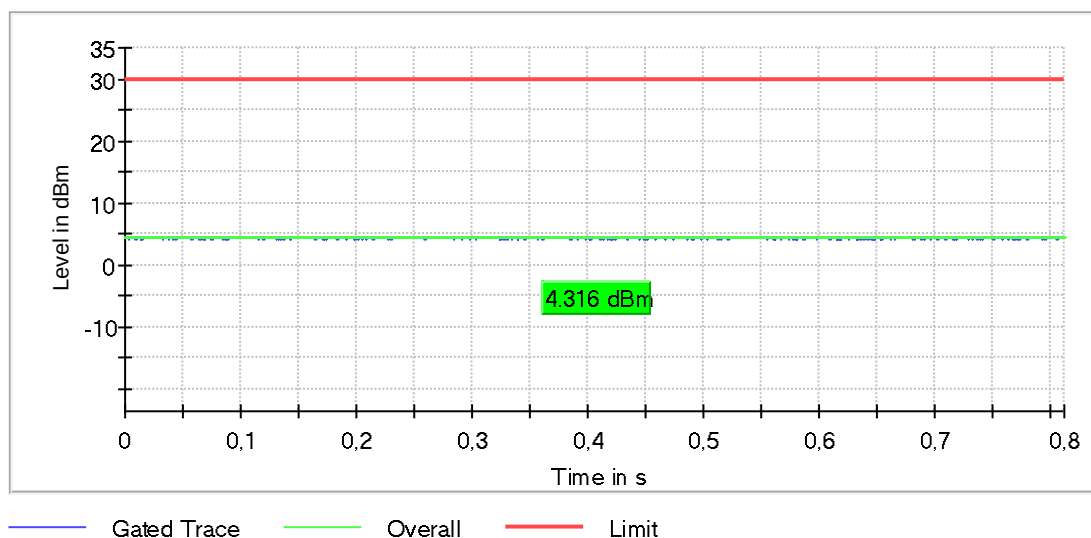
RF output power (5785 MHz; a-mode [24Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	81.440	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

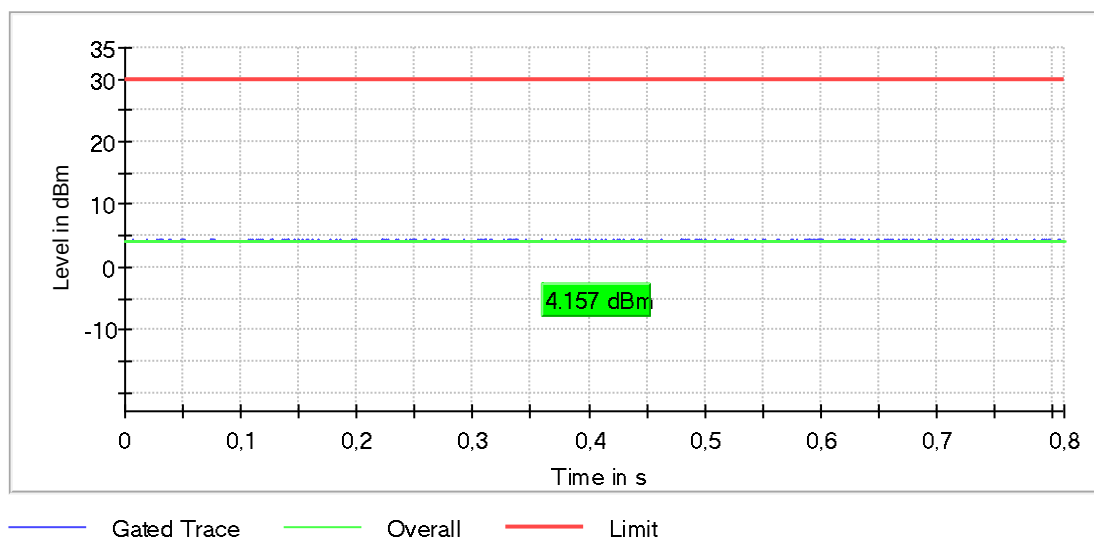
RF output power (5825 MHz; a-mode [24Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.2	30.0	4.2	81.228	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

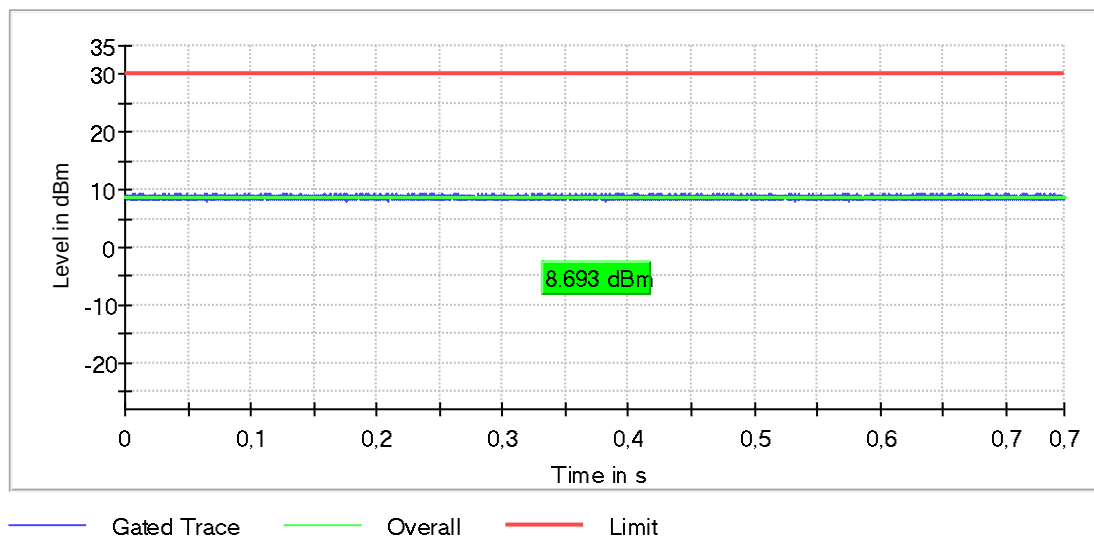
RF output power (5180 MHz; a-mode [36Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.7	30.0	8.7	74.863	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

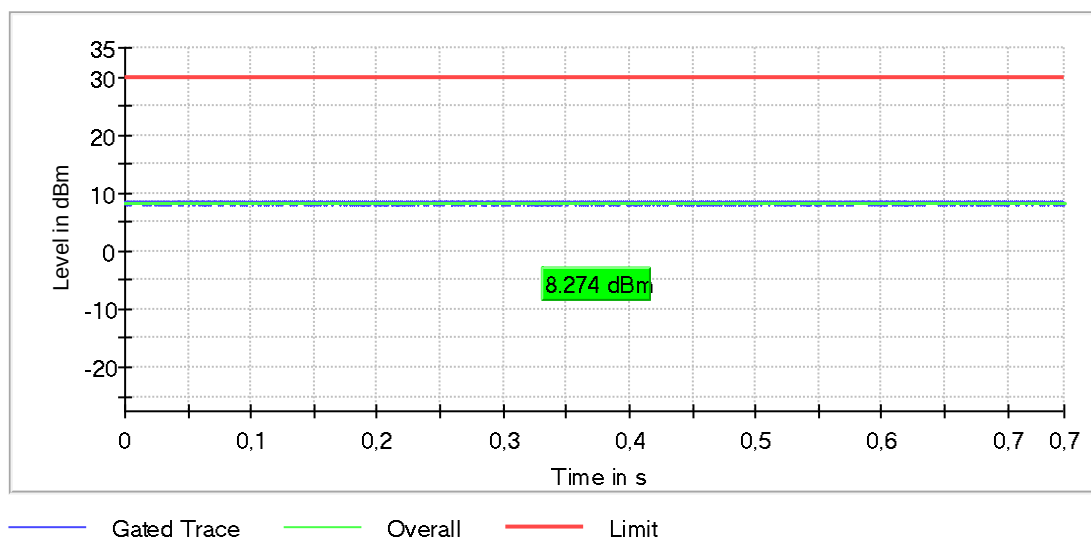
RF output power (5200 MHz; a-mode [36Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.3	30.0	8.3	74.761	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

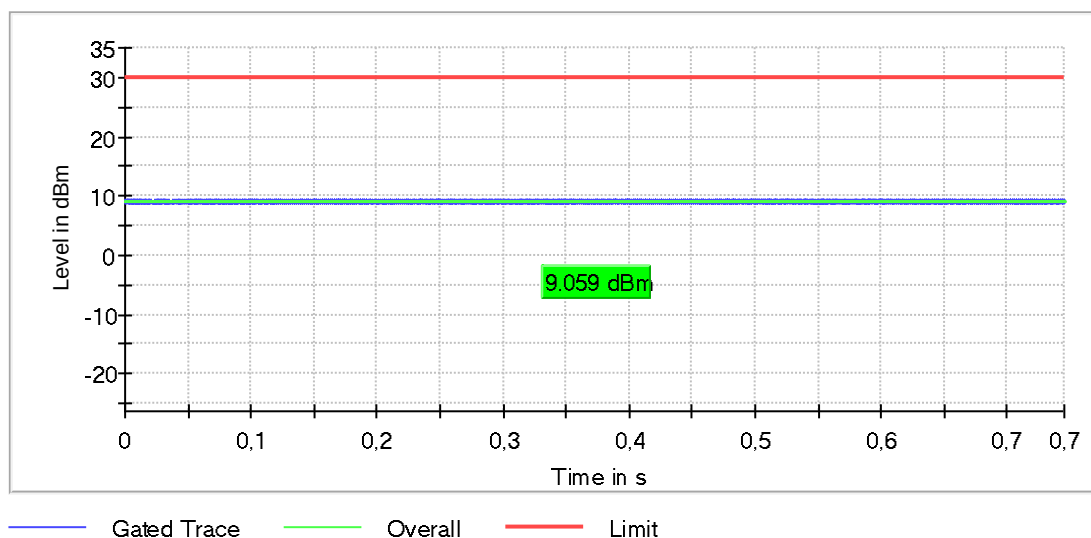
RF output power (5240 MHz; a-mode [36Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.1	30.0	9.1	74.779	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

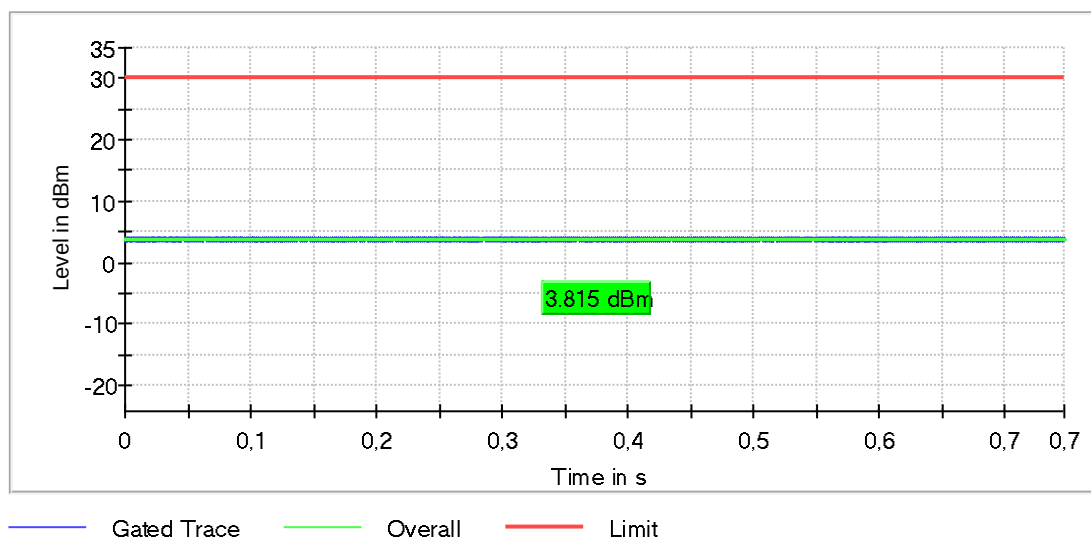
RF output power (5745 MHz; a-mode [36Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.8	30.0	3.8	74.991	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

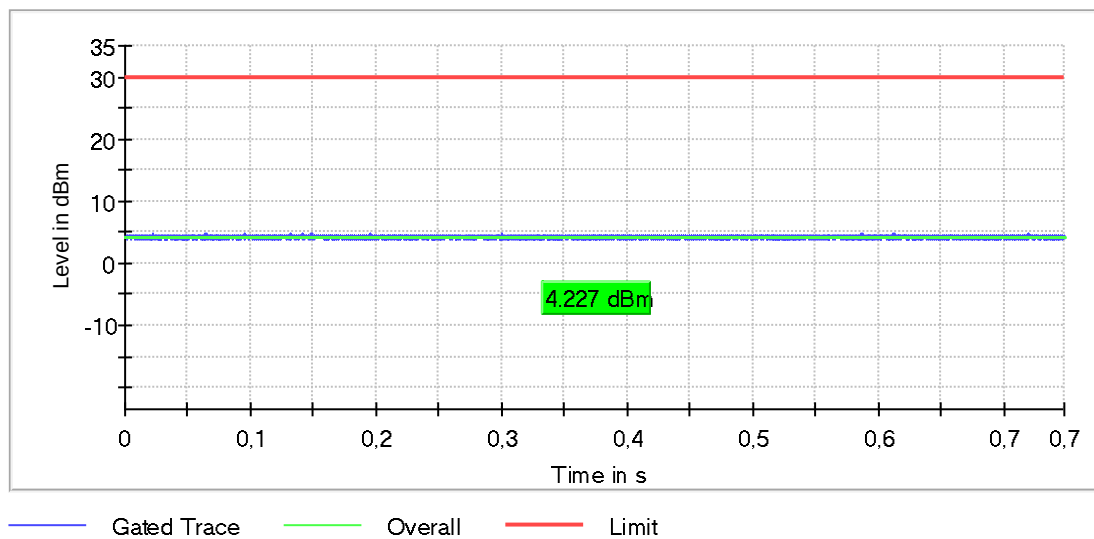
RF output power (5785 MHz; a-mode [36Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.2	30.0	4.2	75.030	PASS

Gated Trace



OSP PowerMeter settings

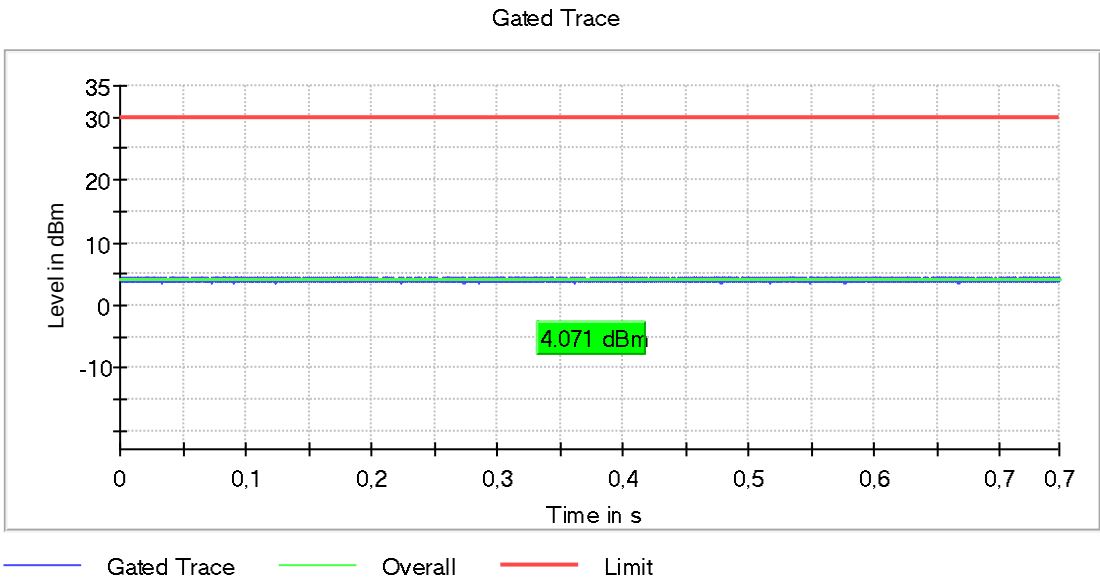
Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

RF output power (5825 MHz; a-mode [36Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.1	30.0	4.1	74.966	PASS



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

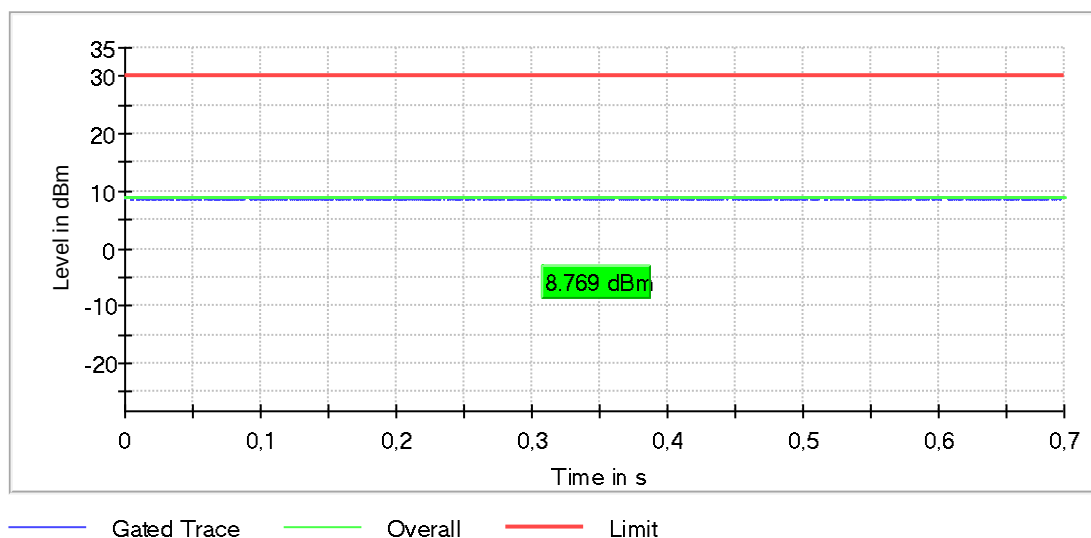
RF output power (5180 MHz; a-mode [48Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.8	30.0	8.8	69.578	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

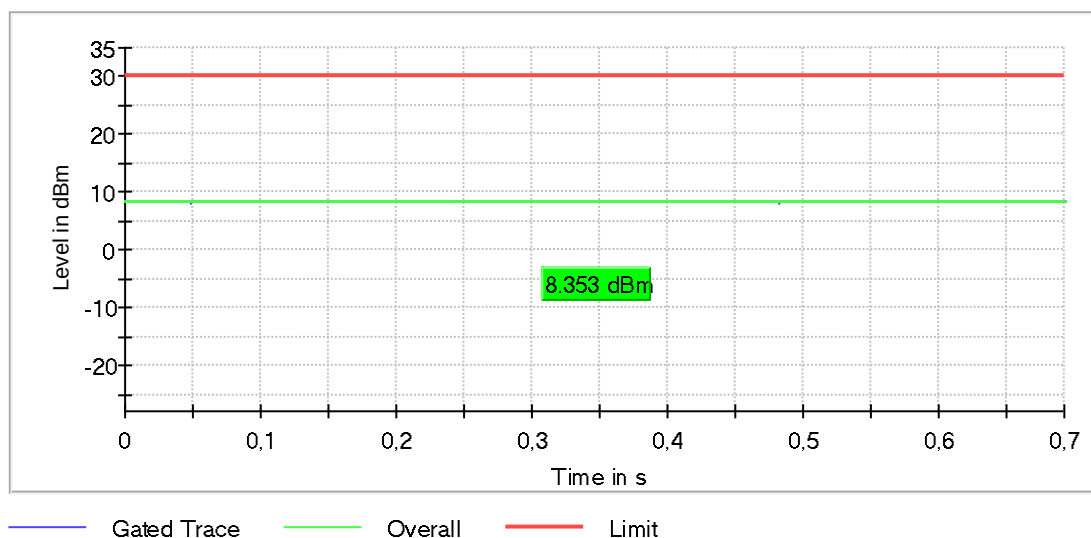
RF output power (5200 MHz; a-mode [48Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.4	30.0	8.4	69.495	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

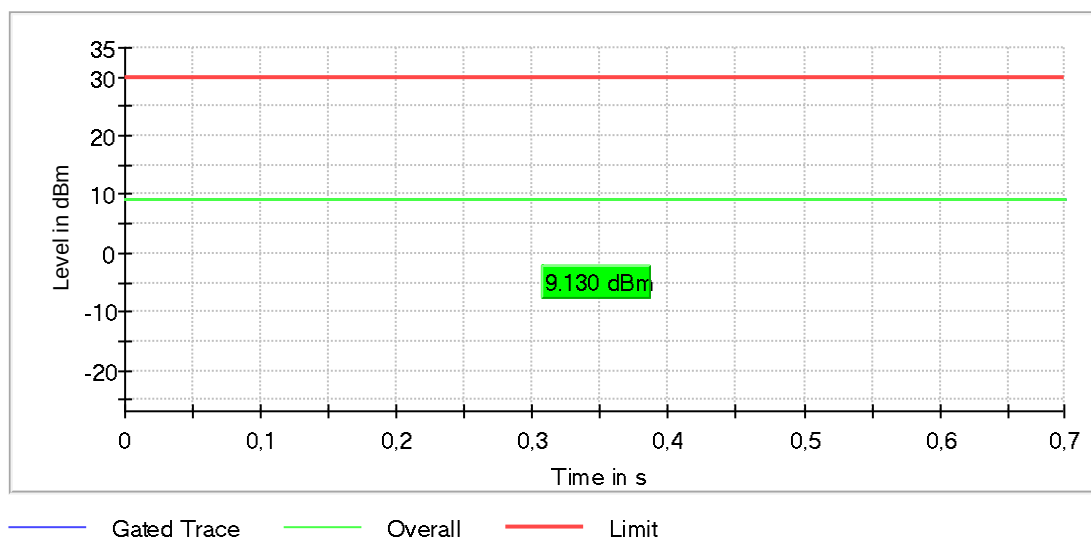
RF output power (5240 MHz; a-mode [48Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.1	30.0	9.1	69.440	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

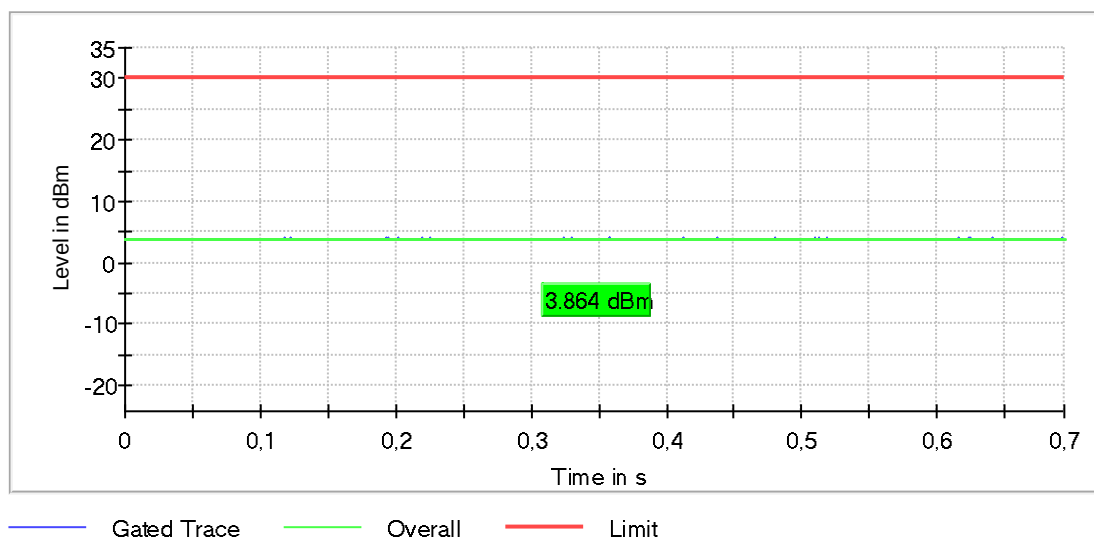
RF output power (5745 MHz; a-mode [48Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.9	30.0	3.9	69.657	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

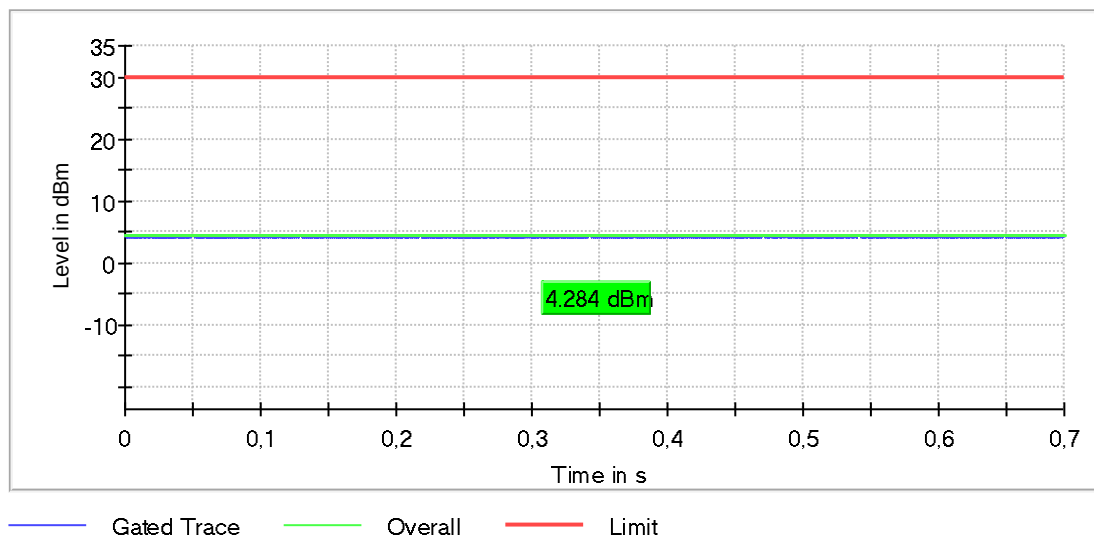
RF output power (5785 MHz; a-mode [48Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	69.531	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

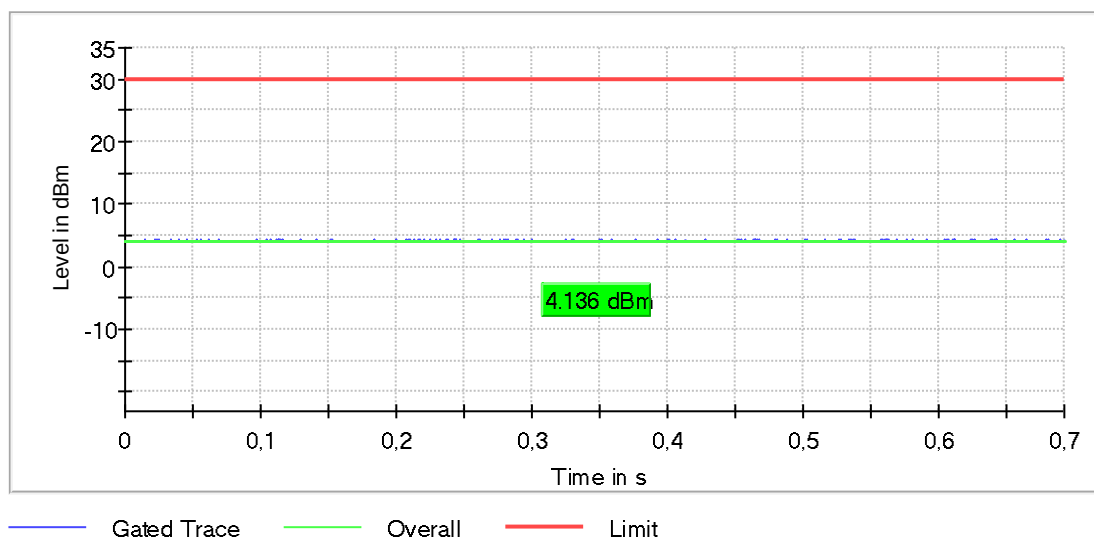
RF output power (5825 MHz; a-mode [48Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.1	30.0	4.1	69.582	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

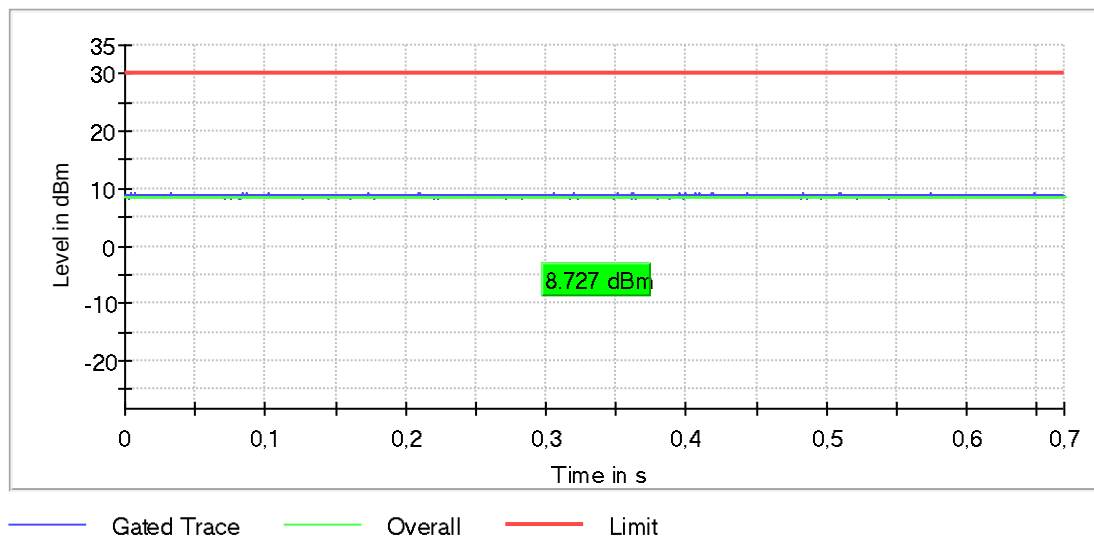
RF output power (5180 MHz; a-mode [54Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.7	30.0	8.7	67.225	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

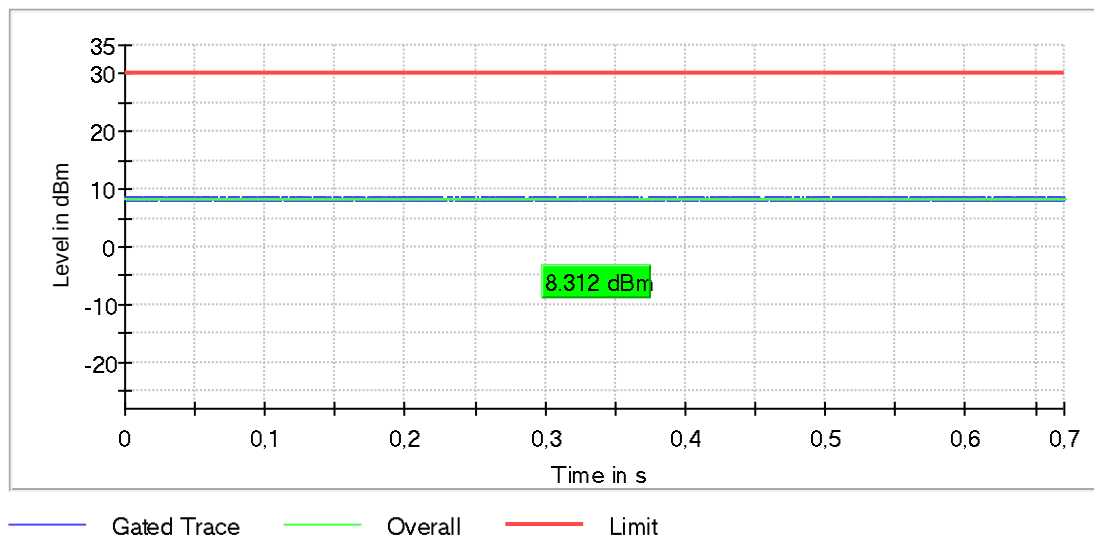
RF output power (5200 MHz; a-mode [54Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.3	30.0	8.3	67.360	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

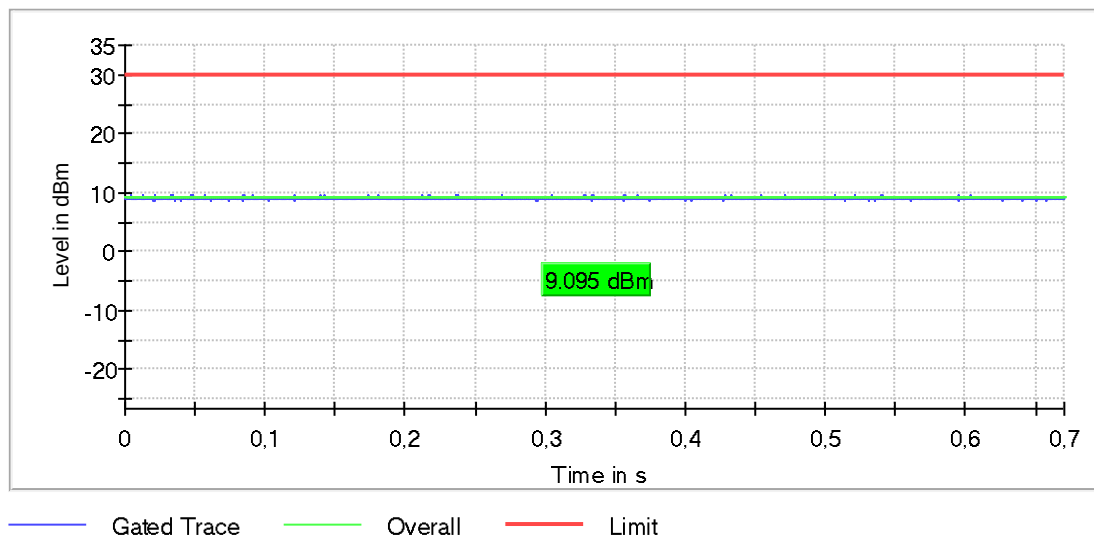
RF output power (5240 MHz; a-mode [54Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.1	30.0	9.1	67.352	PASS

Gated Trace



OSP PowerMeter settings

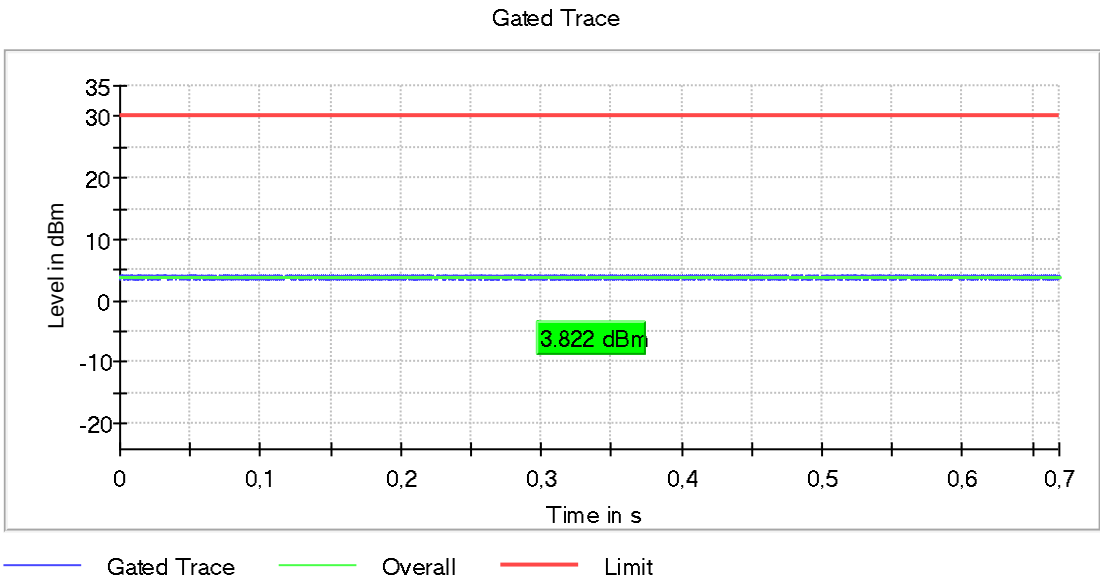
Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

RF output power (5745 MHz; a-mode [54Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.8	30.0	3.8	67.217	PASS



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

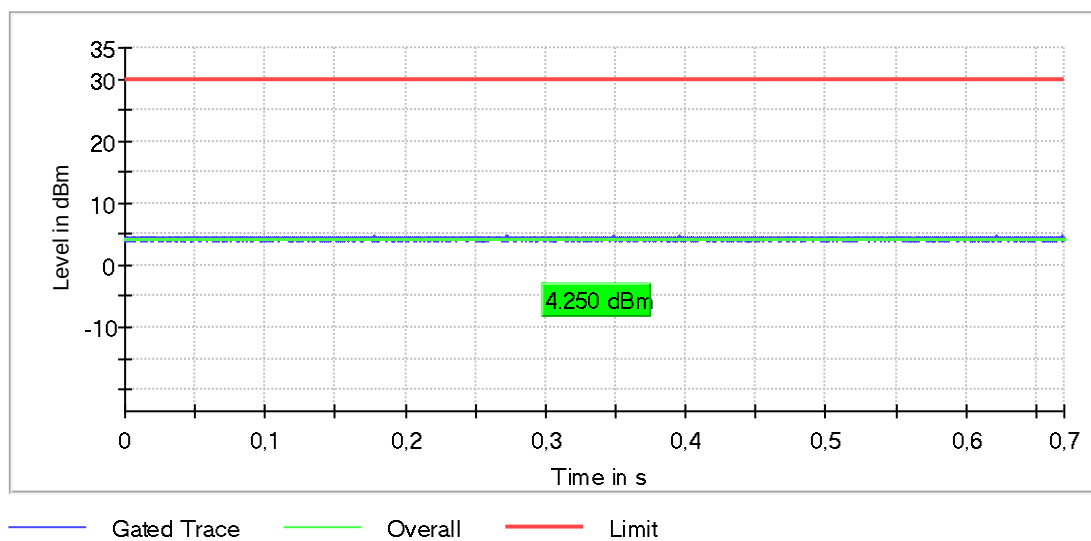
RF output power (5785 MHz; a-mode [54Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.2	30.0	4.2	67.293	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

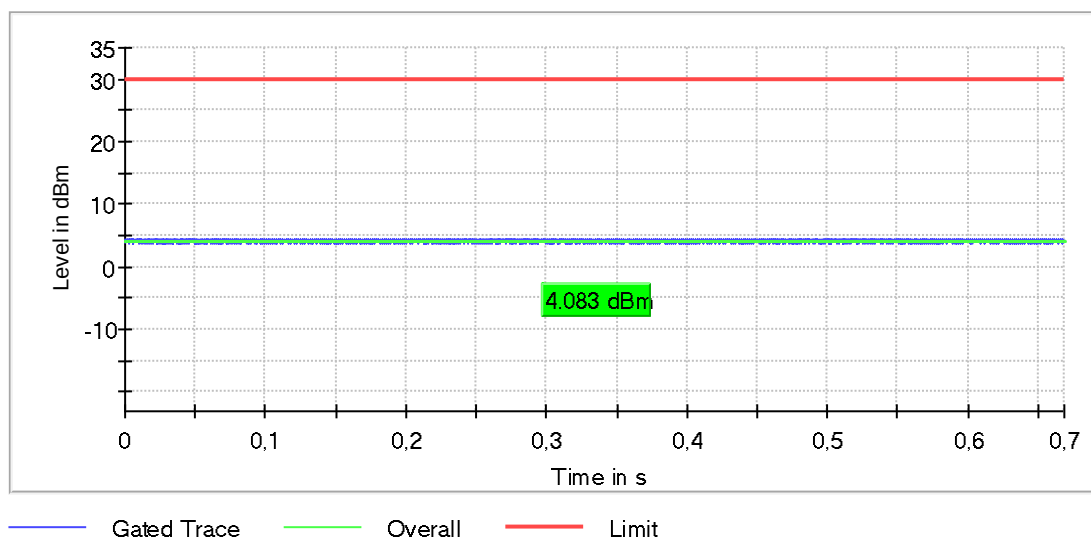
RF output power (5825 MHz; a-mode [54Mbps] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.1	30.0	4.1	67.157	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

RF output power

Mode	DUT Frequency	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
n20-mode [MCS0]; 5180MHz	5180.0000	8.2	30.0	8.2	93.763	PASS
n20-mode [MCS0]; 5200MHz	5200.0000	7.8	30.0	7.8	93.819	PASS
n20-mode [MCS0]; 5240MHz	5240.0000	8.6	30.0	8.6	93.845	PASS
n20-mode [MCS0]; 5745MHz	5745.0000	3.2	30.0	3.2	93.973	PASS
n20-mode [MCS0]; 5785MHz	5785.0000	3.7	30.0	3.7	93.871	PASS
n20-mode [MCS0]; 5825MHz	5825.0000	3.5	30.0	3.5	93.916	PASS
n20-mode [MCS1]; 5180MHz	5180.0000	8.1	30.0	8.1	88.756	PASS
n20-mode [MCS1]; 5200MHz	5200.0000	7.7	30.0	7.7	88.919	PASS
n20-mode [MCS1]; 5240MHz	5240.0000	8.5	30.0	8.5	88.909	PASS
n20-mode [MCS1]; 5745MHz	5745.0000	3.1	30.0	3.1	88.954	PASS
n20-mode [MCS1]; 5785MHz	5785.0000	3.6	30.0	3.6	88.816	PASS
n20-mode [MCS1]; 5825MHz	5825.0000	3.4	30.0	3.4	89.005	PASS
n20-mode [MCS2]; 5180MHz	5180.0000	8.3	30.0	8.3	84.527	PASS
n20-mode [MCS2]; 5200MHz	5200.0000	7.9	30.0	7.9	84.415	PASS
n20-mode [MCS2]; 5240MHz	5240.0000	8.7	30.0	8.7	84.444	PASS
n20-mode [MCS2]; 5745MHz	5745.0000	3.3	30.0	3.3	84.629	PASS
n20-mode [MCS2]; 5785MHz	5785.0000	3.8	30.0	3.8	84.553	PASS
n20-mode [MCS2]; 5825MHz	5825.0000	3.6	30.0	3.6	84.585	PASS
n20-mode [MCS3]; 5180MHz	5180.0000	8.8	30.0	8.8	80.698	PASS
n20-mode [MCS3]; 5200MHz	5200.0000	8.4	30.0	8.4	80.733	PASS
n20-mode [MCS3]; 5240MHz	5240.0000	9.1	30.0	9.1	80.830	PASS
n20-mode [MCS3]; 5745MHz	5745.0000	3.9	30.0	3.9	80.783	PASS
n20-mode [MCS3]; 5785MHz	5785.0000	4.3	30.0	4.3	80.697	PASS
n20-mode [MCS3]; 5825MHz	5825.0000	4.1	30.0	4.1	80.788	PASS
n20-mode [MCS4]; 5180MHz	5180.0000	8.8	30.0	8.8	74.205	PASS
n20-mode [MCS4]; 5200MHz	5200.0000	8.4	30.0	8.4	74.388	PASS
n20-mode [MCS4]; 5240MHz	5240.0000	9.1	30.0	9.1	74.336	PASS
n20-mode [MCS4]; 5745MHz	5745.0000	3.9	30.0	3.9	74.532	PASS
n20-mode [MCS4]; 5785MHz	5785.0000	4.3	30.0	4.3	74.503	PASS
n20-mode [MCS4]; 5825MHz	5825.0000	4.1	30.0	4.1	74.389	PASS
n20-mode [MCS5]; 5180MHz	5180.0000	8.8	30.0	8.8	69.186	PASS
n20-mode [MCS5]; 5200MHz	5200.0000	8.4	30.0	8.4	69.100	PASS
n20-mode [MCS5]; 5240MHz	5240.0000	9.1	30.0	9.1	68.931	PASS
n20-mode [MCS5]; 5745MHz	5745.0000	5.9	30.0	5.9	68.687	PASS
n20-mode [MCS5]; 5785MHz	5785.0000	4.3	30.0	4.3	69.314	PASS
n20-mode [MCS5]; 5825MHz	5825.0000	4.1	30.0	4.1	69.321	PASS
n20-mode [MCS6]; 5180MHz	5180.0000	8.8	30.0	8.8	67.252	PASS
n20-mode [MCS6]; 5200MHz	5200.0000	8.4	30.0	8.4	67.246	PASS
n20-mode [MCS6]; 5240MHz	5240.0000	9.2	30.0	9.2	67.092	PASS
n20-mode [MCS6]; 5745MHz	5745.0000	3.9	30.0	3.9	67.285	PASS
n20-mode [MCS6]; 5785MHz	5785.0000	4.3	30.0	4.3	67.338	PASS
n20-mode [MCS6]; 5825MHz	5825.0000	4.2	30.0	4.2	67.207	PASS
n20-mode [MCS7]; 5180MHz	5180.0000	8.8	30.0	8.8	65.281	PASS
n20-mode [MCS7]; 5200MHz	5200.0000	8.3	30.0	8.3	65.282	PASS
n20-mode [MCS7]; 5240MHz	5240.0000	9.1	30.0	9.1	65.324	PASS
n20-mode [MCS7]; 5745MHz	5745.0000	3.8	30.0	3.8	65.352	PASS
n20-mode [MCS7]; 5785MHz	5785.0000	4.3	30.0	4.3	65.606	PASS
n20-mode [MCS7]; 5825MHz	5825.0000	4.1	30.0	4.1	65.714	PASS

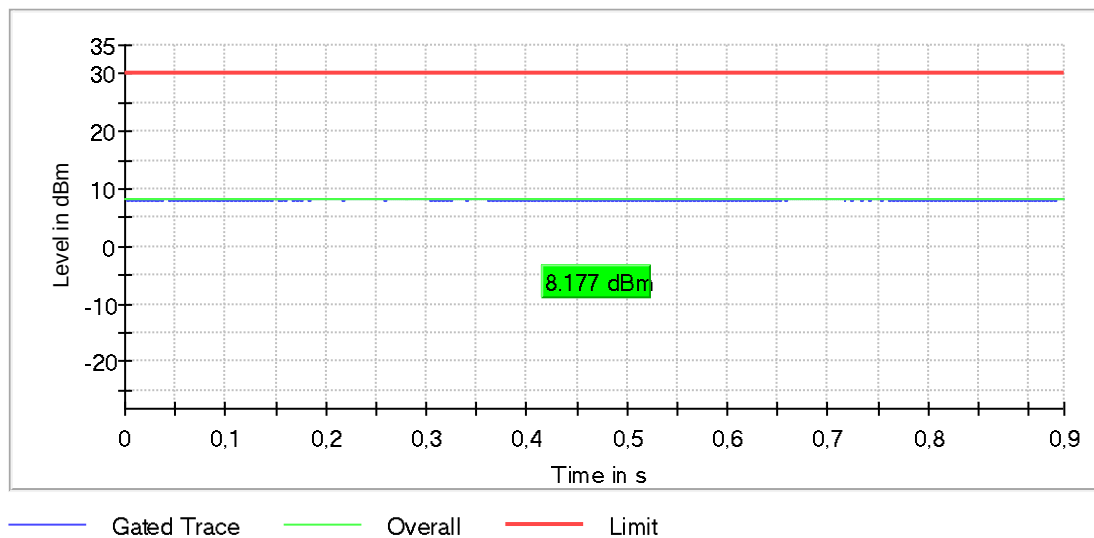
RF output power (5180 MHz; n20-mode [MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.2	30.0	8.2	93.763	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

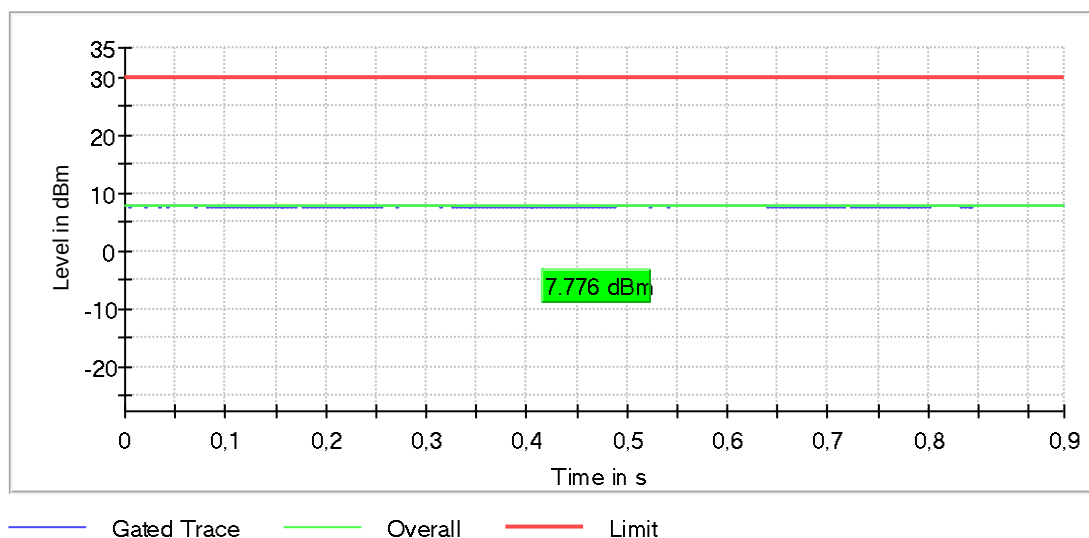
RF output power (5200 MHz; n20-mode [MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	7.8	30.0	7.8	93.819	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

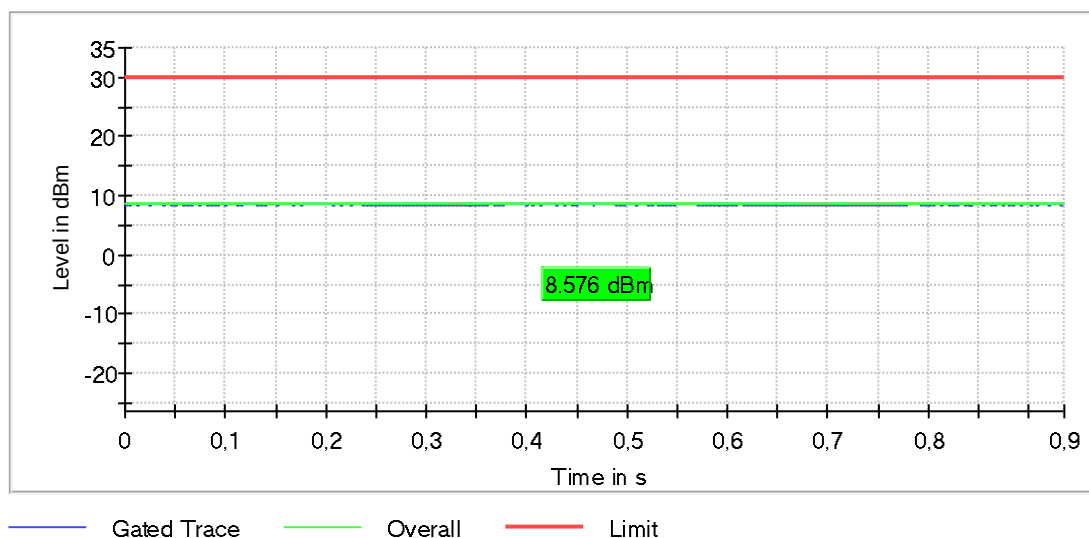
RF output power (5240 MHz; n20-mode [MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	8.6	30.0	8.6	93.845	PASS

Gated Trace



OSP PowerMeter settings

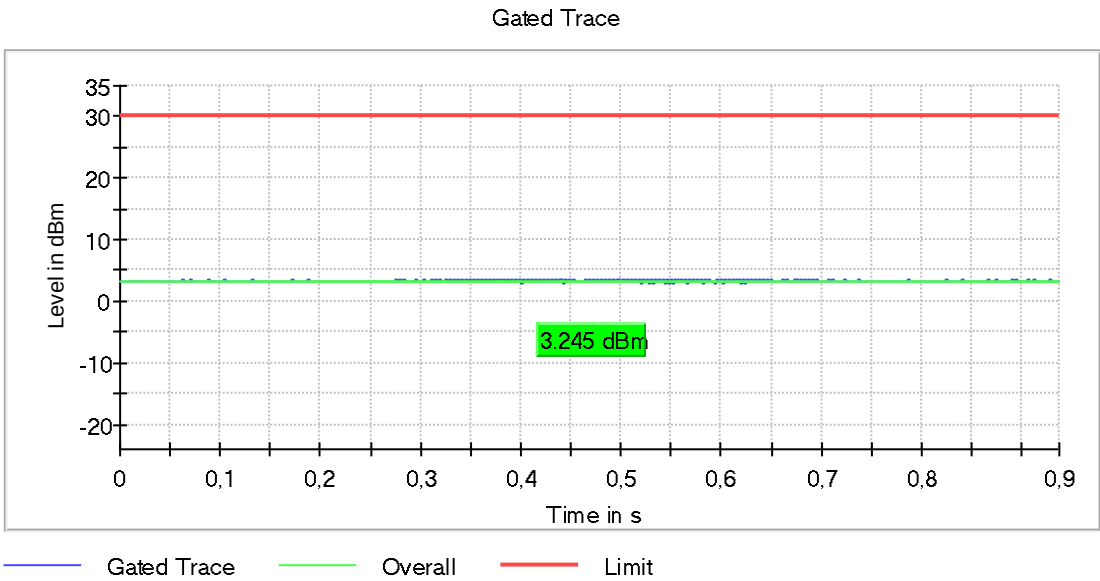
Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

RF output power (5745 MHz; n20-mode [MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.2	30.0	3.2	93.973	PASS



OSP PowerMeter settings

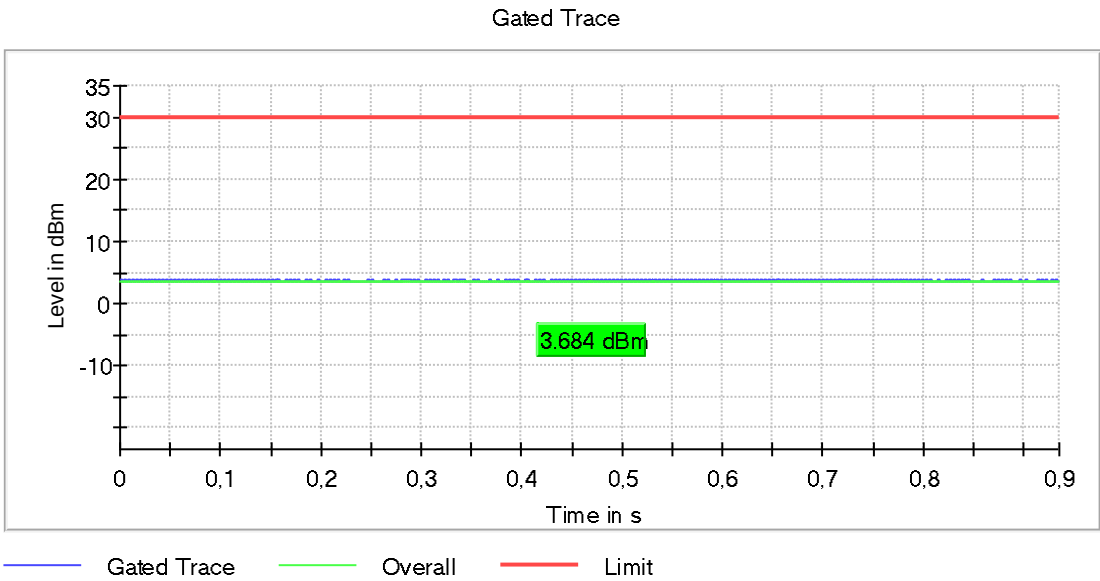
Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

RF output power (5785 MHz; n20-mode [MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	3.7	30.0	3.7	93.871	PASS



OSP PowerMeter settings

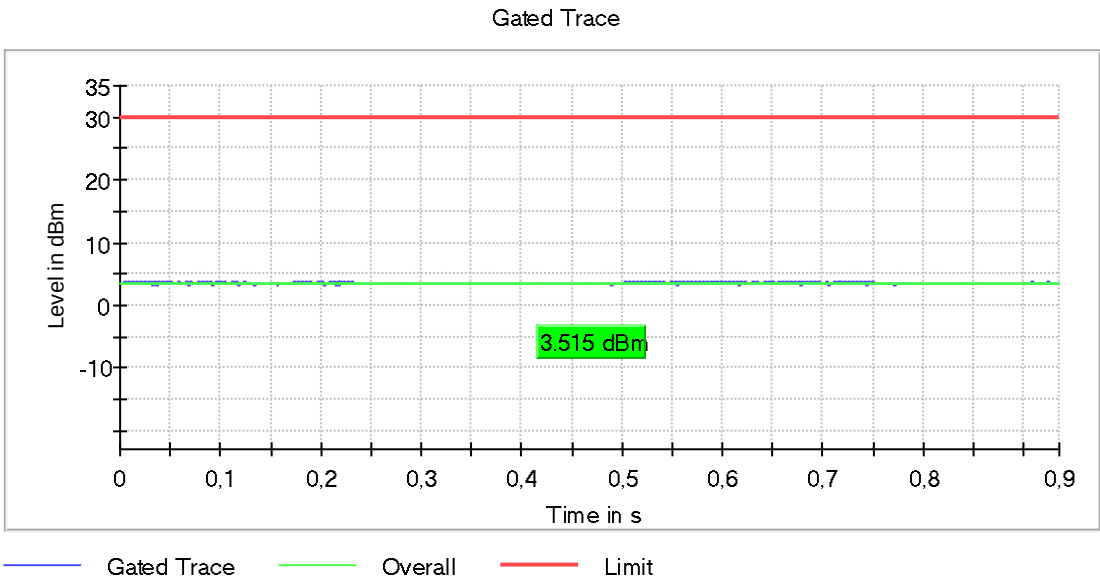
Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

RF output power (5825 MHz; n20-mode [MCS0] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	3.5	30.0	3.5	93.916	PASS



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

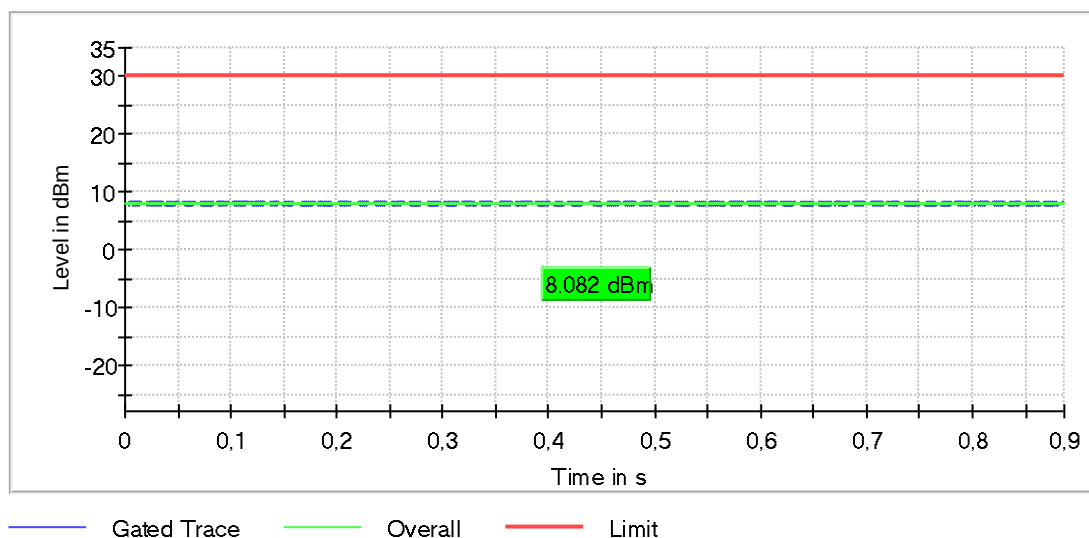
RF output power (5180 MHz; n20-mode [MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.1	30.0	8.1	88.756	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

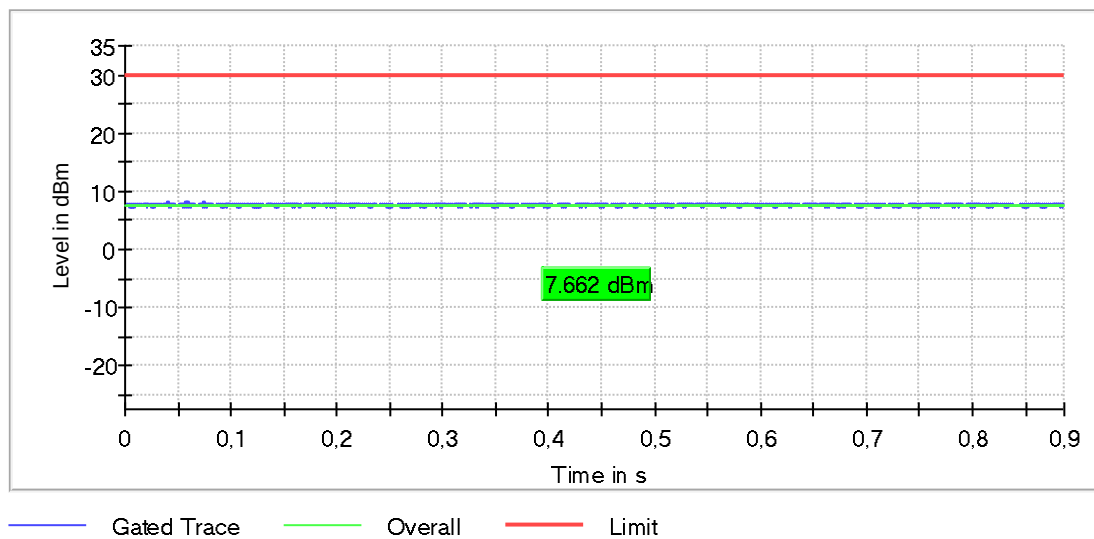
RF output power (5200 MHz; n20-mode [MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	7.7	30.0	7.7	88.919	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

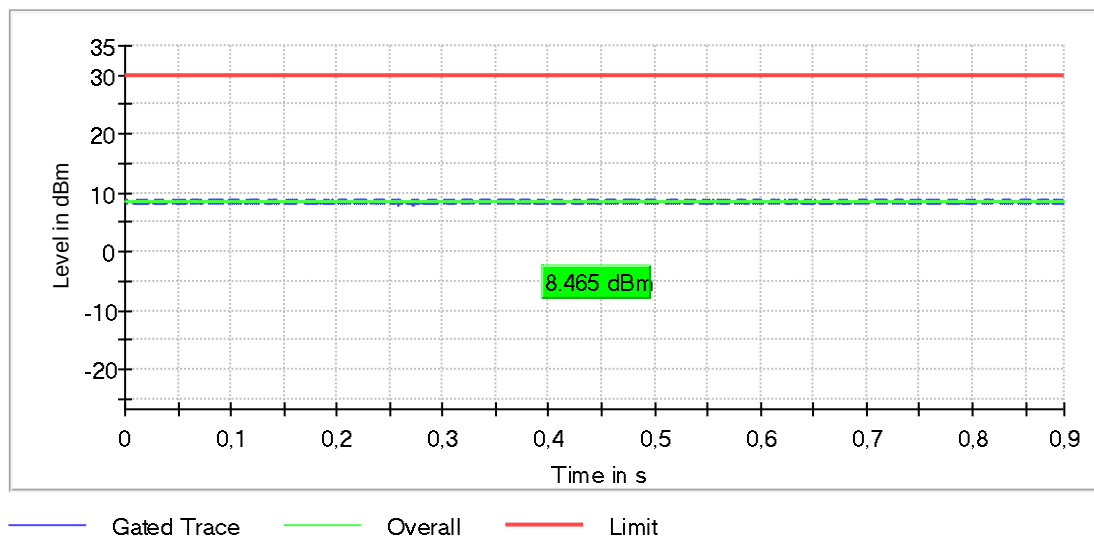
RF output power (5240 MHz; n20-mode [MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	8.5	30.0	8.5	88.909	PASS

Gated Trace



OSP PowerMeter settings

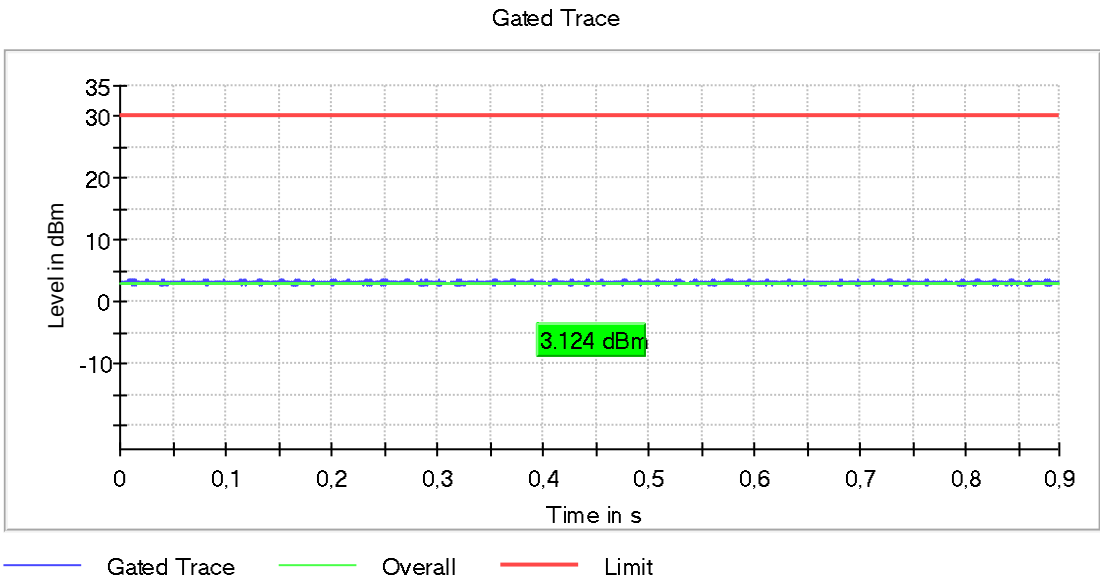
Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

RF output power (5745 MHz; n20-mode [MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.1	30.0	3.1	88.954	PASS



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 µs	1.000 µs

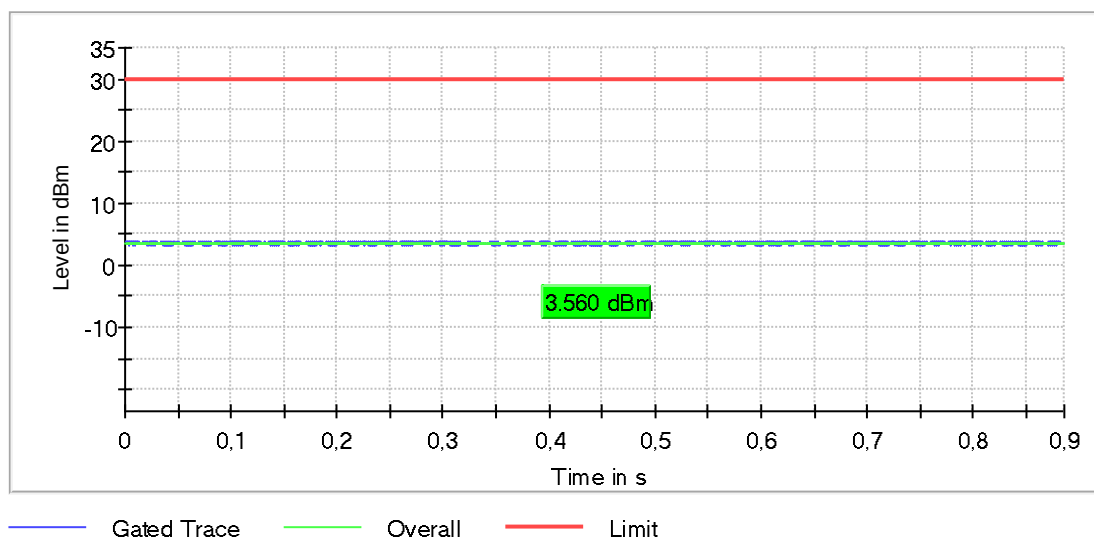
RF output power (5785 MHz; n20-mode [MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	3.6	30.0	3.6	88.816	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

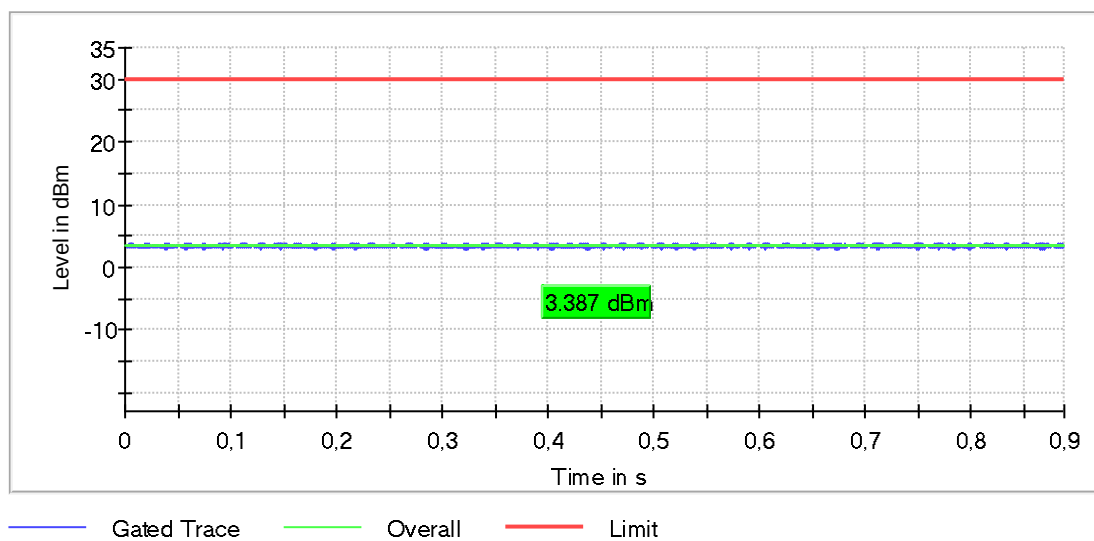
RF output power (5825 MHz; n20-mode [MCS1] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	3.4	30.0	3.4	89.005	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

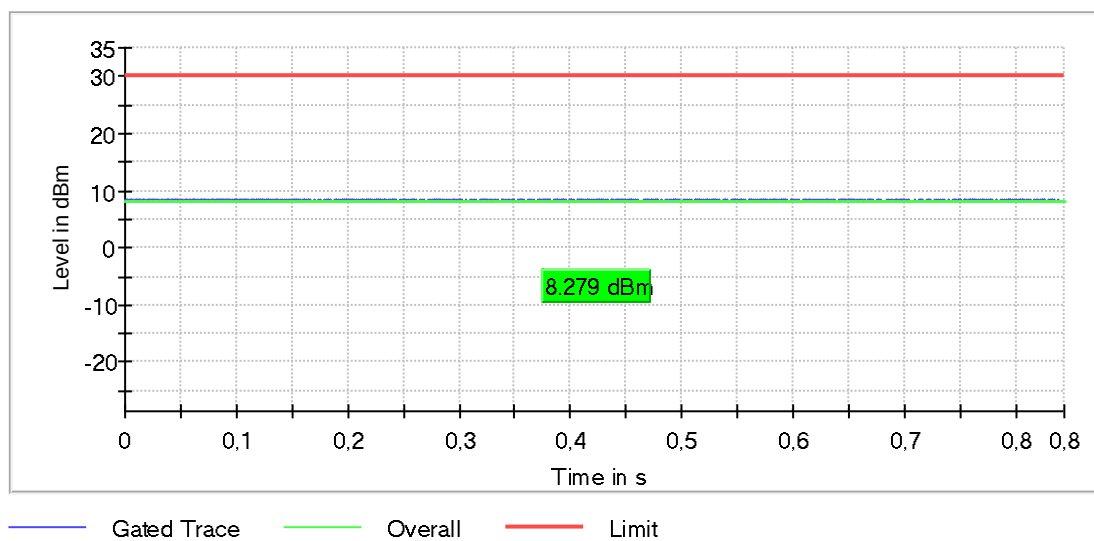
RF output power (5180 MHz; n20-mode [MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.3	30.0	8.3	84.527	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

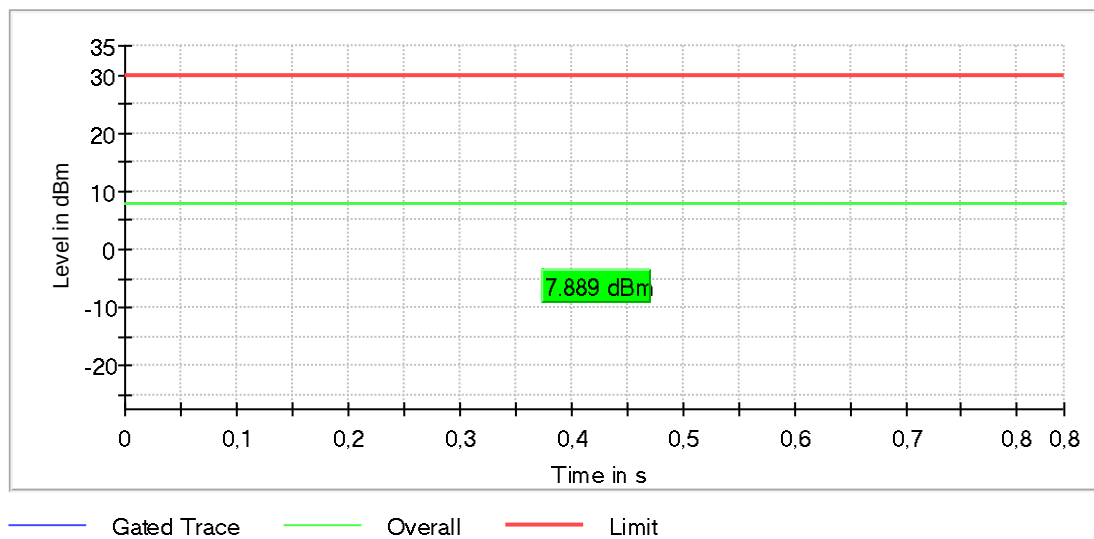
RF output power (5200 MHz; n20-mode [MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	7.9	30.0	7.9	84.415	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

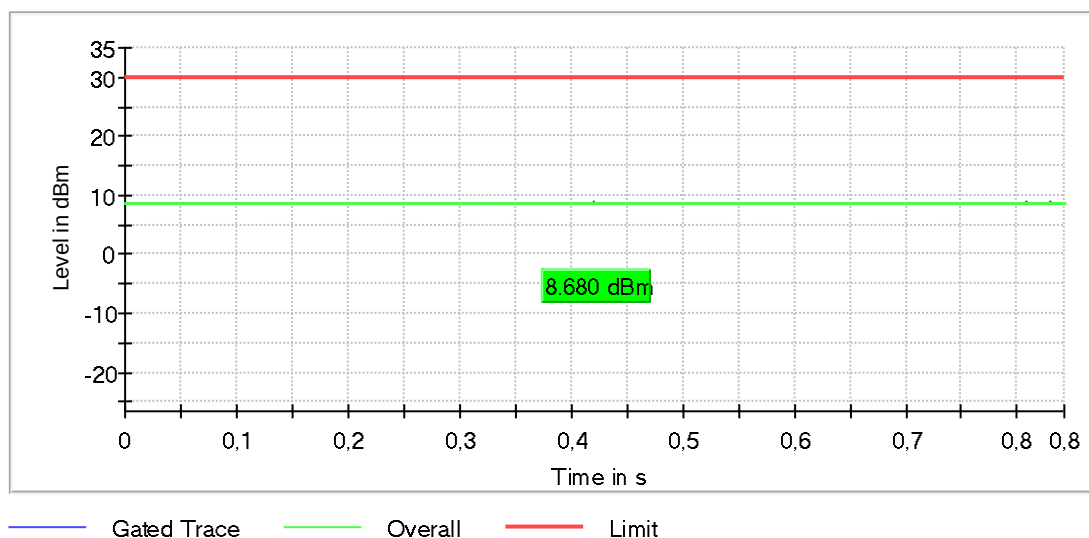
RF output power (5240 MHz; n20-mode [MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	8.7	30.0	8.7	84.444	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

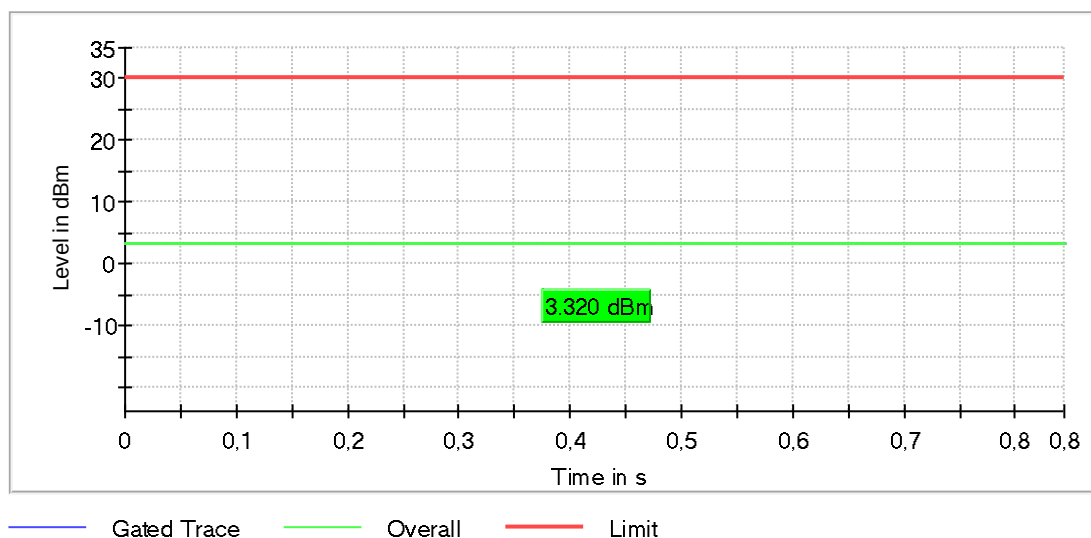
RF output power (5745 MHz; n20-mode [MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.3	30.0	3.3	84.629	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

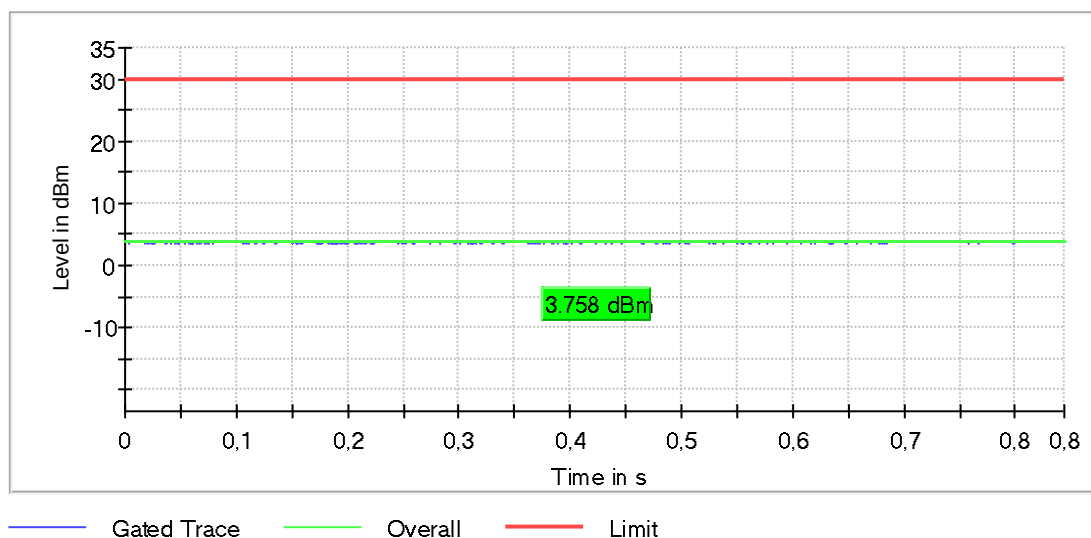
RF output power (5785 MHz; n20-mode [MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	3.8	30.0	3.8	84.553	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

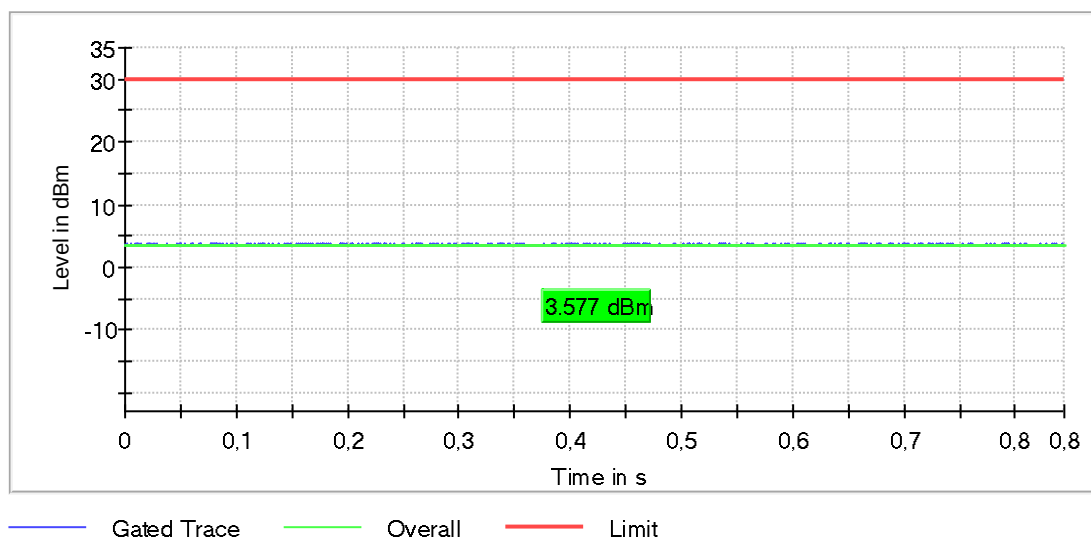
RF output power (5825 MHz; n20-mode [MCS2] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	3.6	30.0	3.6	84.585	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

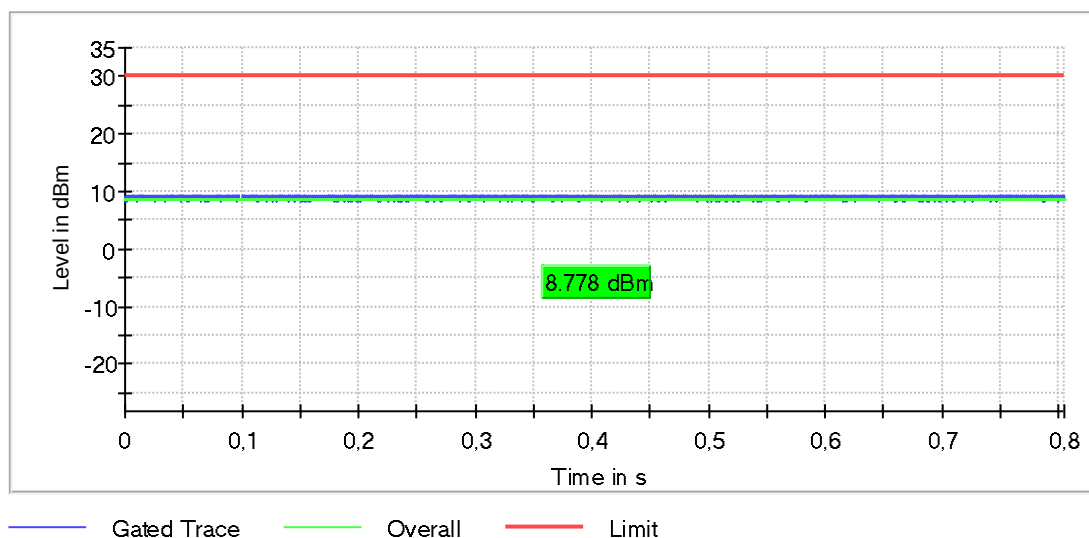
RF output power (5180 MHz; n20-mode [MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.8	30.0	8.8	80.698	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

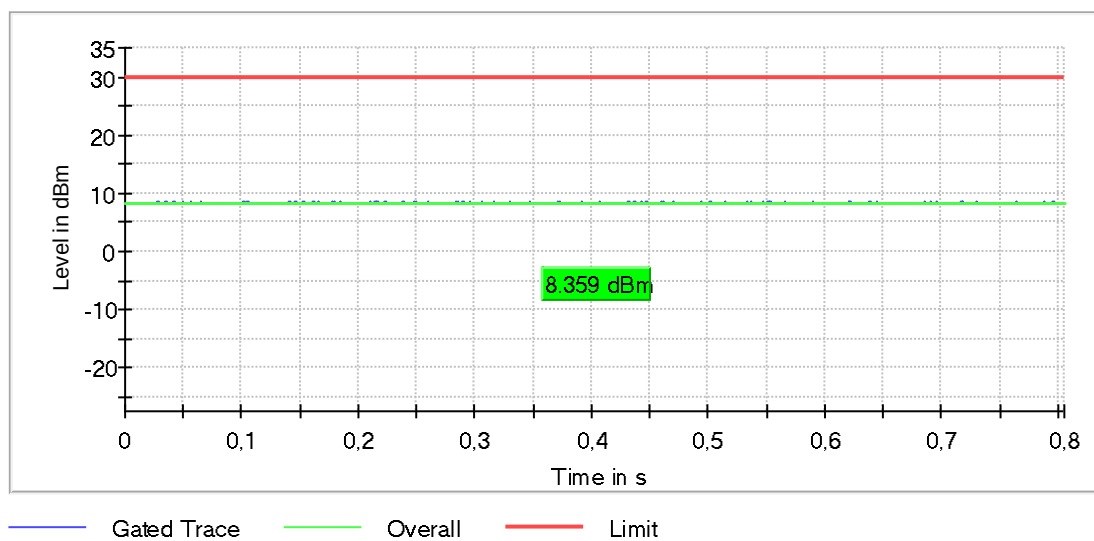
RF output power (5200 MHz; n20-mode [MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.4	30.0	8.4	80.733	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

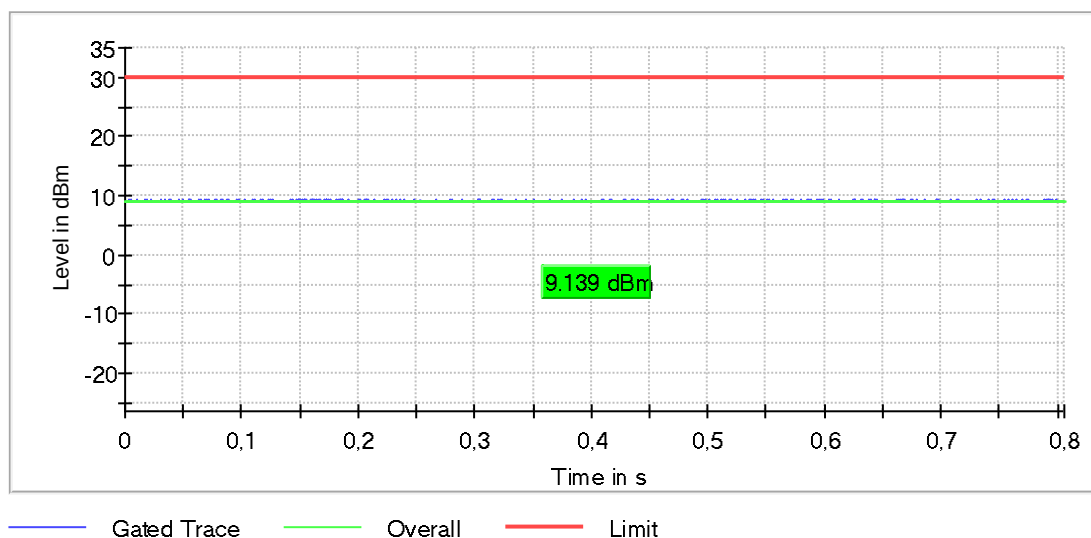
RF output power (5240 MHz; n20-mode [MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.1	30.0	9.1	80.830	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

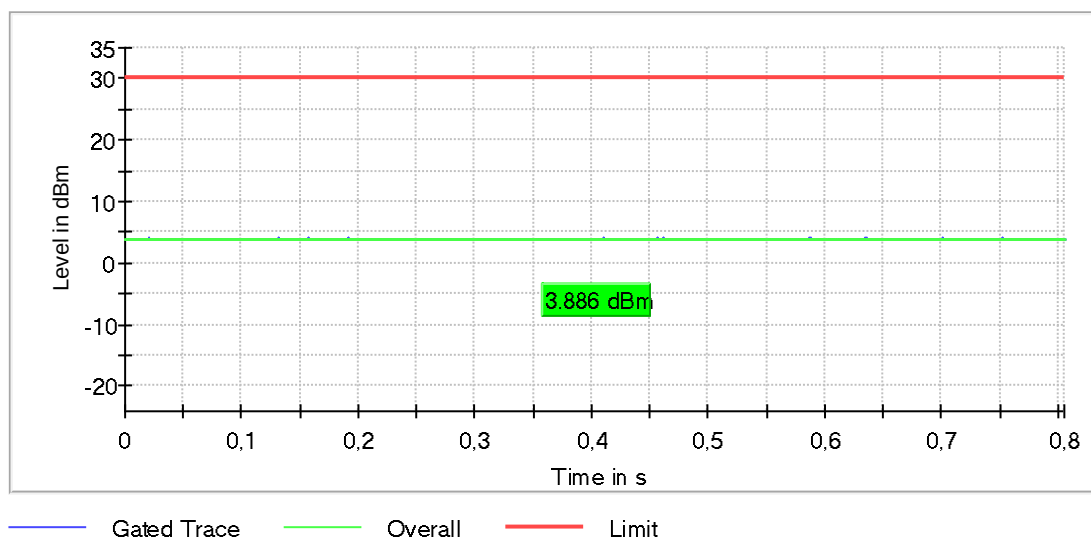
RF output power (5745 MHz; n20-mode [MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.9	30.0	3.9	80.783	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

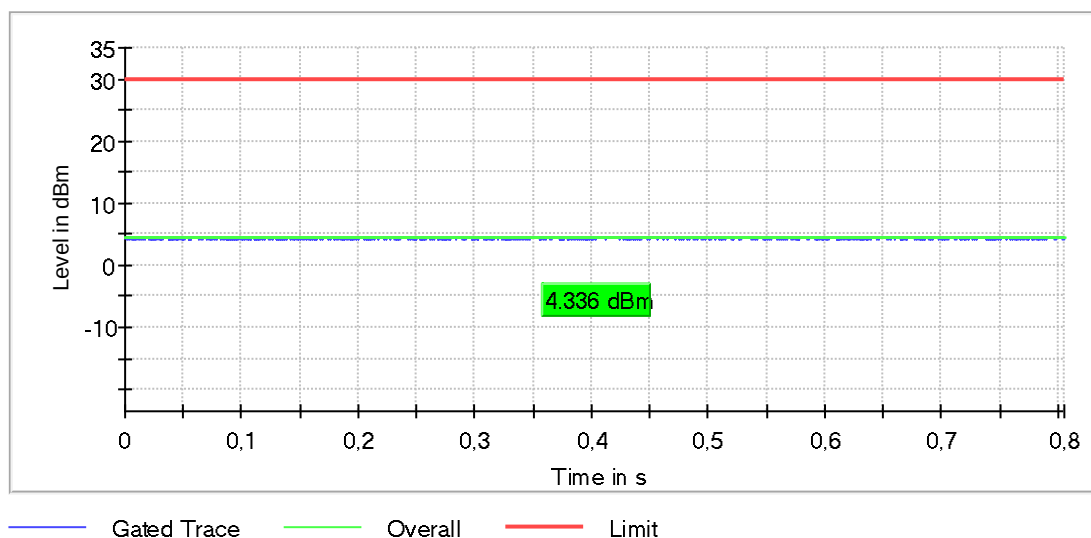
RF output power (5785 MHz; n20-mode [MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	80.697	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

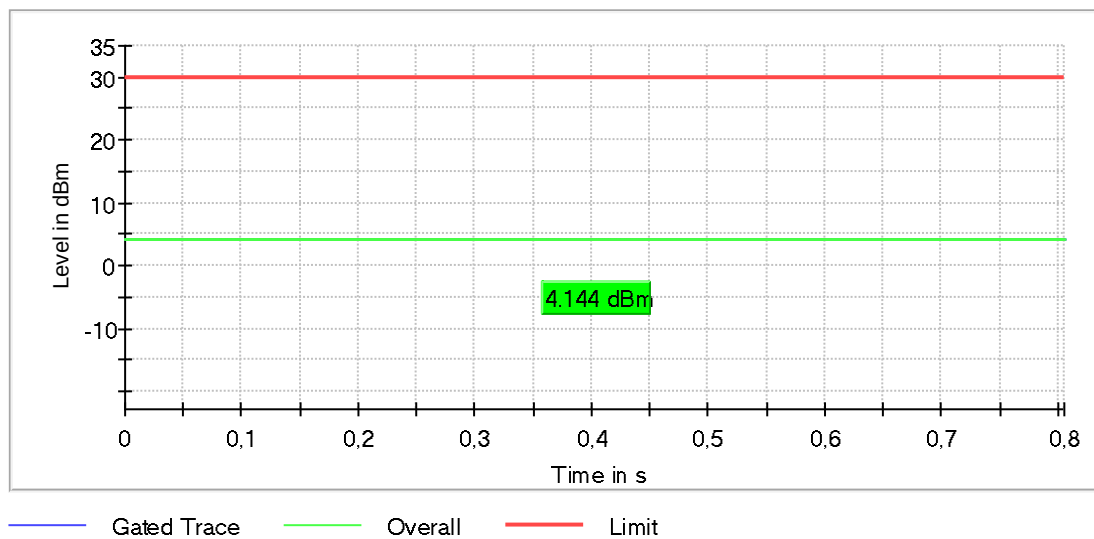
RF output power (5825 MHz; n20-mode [MCS3] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.1	30.0	4.1	80.788	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

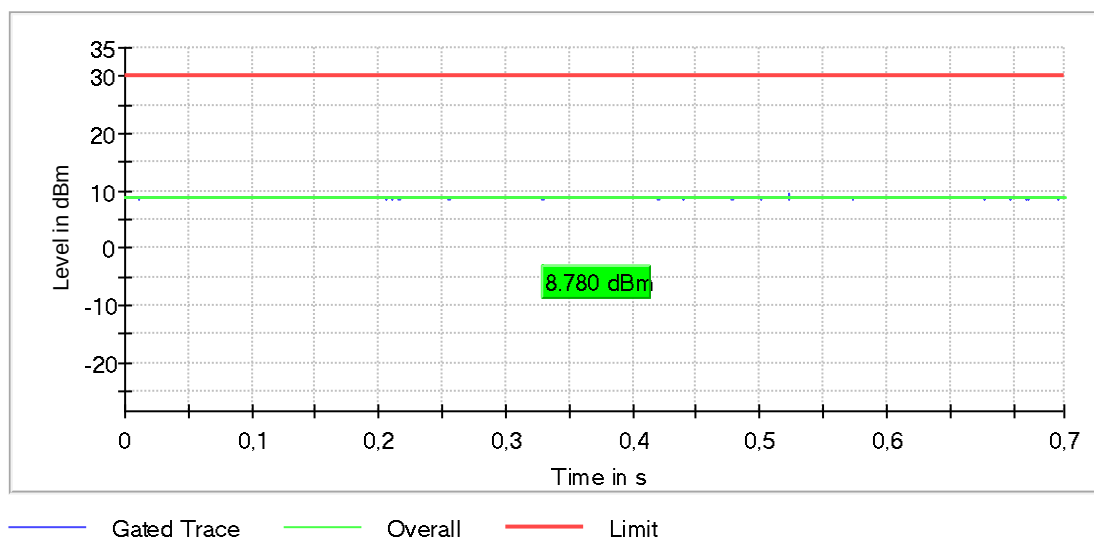
RF output power (5180 MHz; n20-mode [MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.8	30.0	8.8	74.205	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

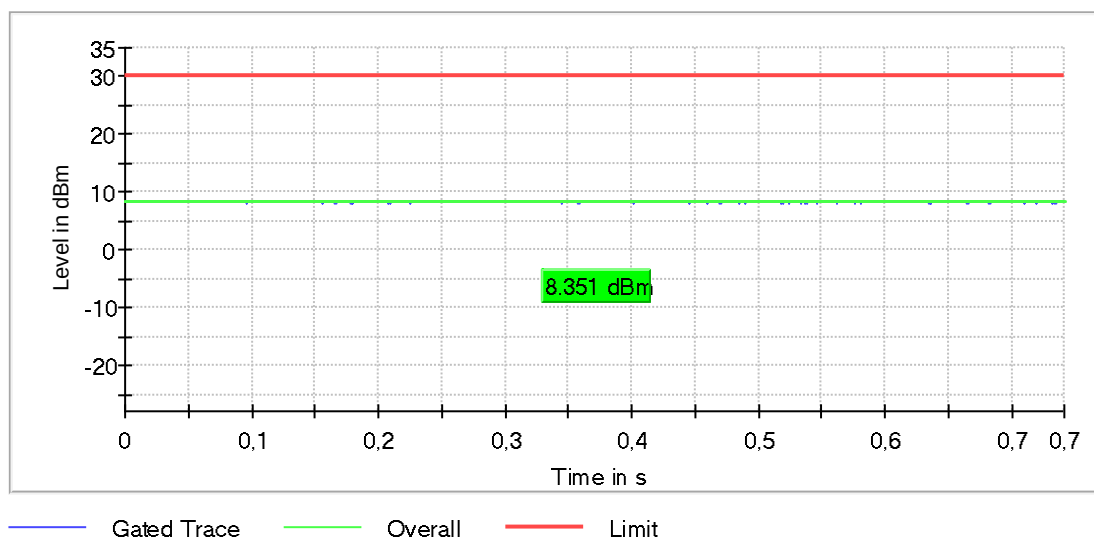
RF output power (5200 MHz; n20-mode [MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.4	30.0	8.4	74.388	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

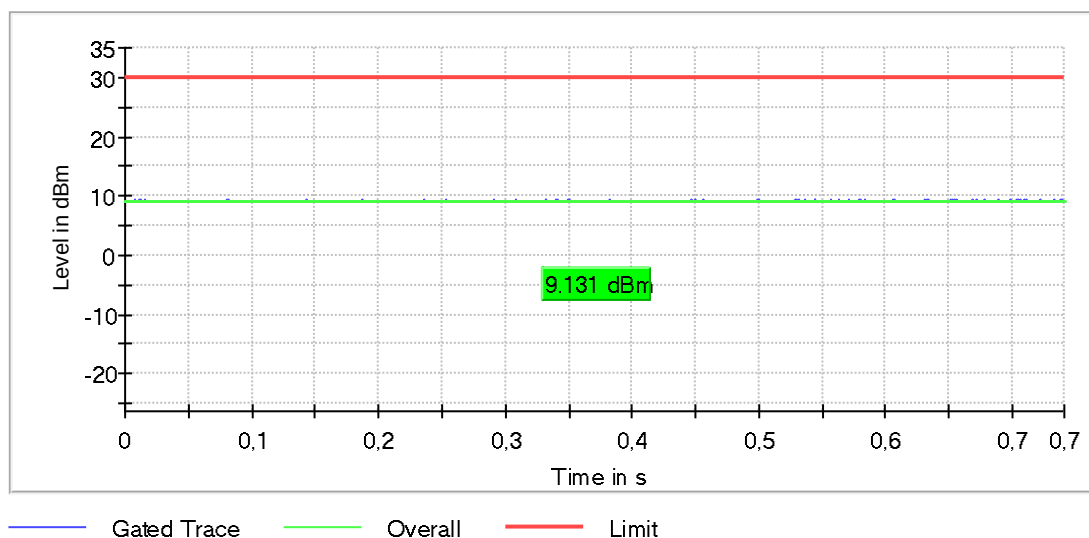
RF output power (5240 MHz; n20-mode [MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.1	30.0	9.1	74.336	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

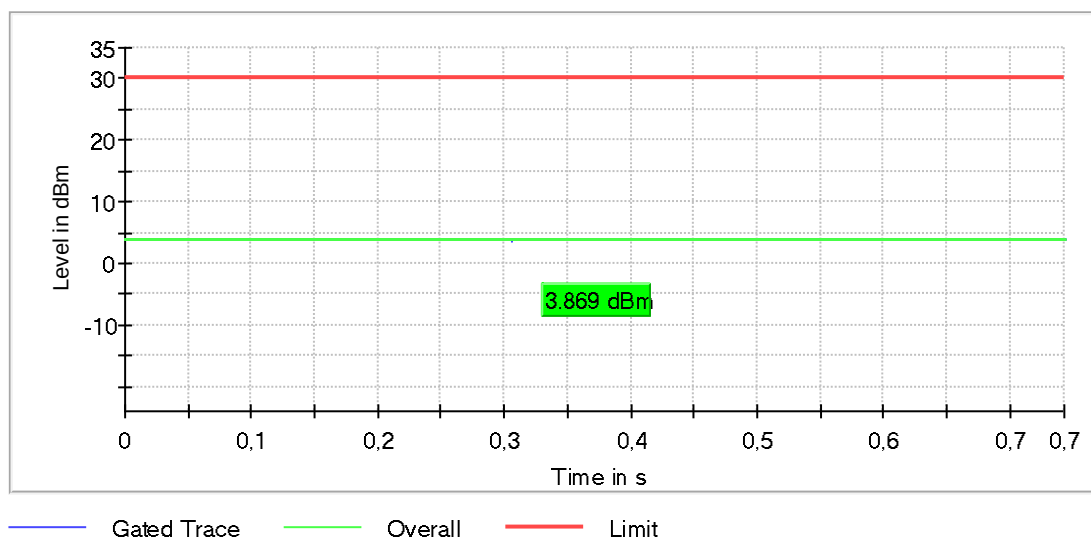
RF output power (5745 MHz; n20-mode [MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.9	30.0	3.9	74.532	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

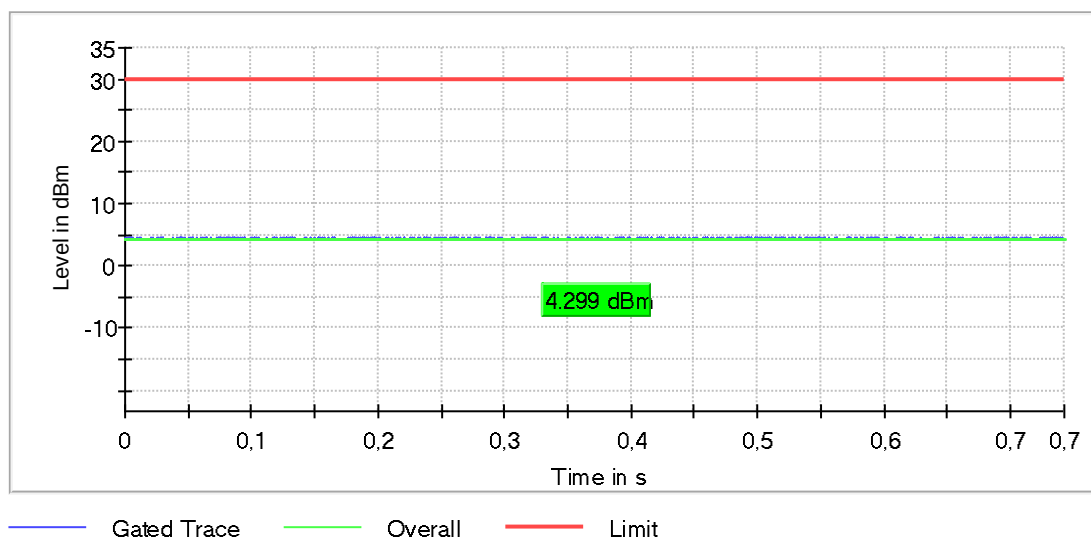
RF output power (5785 MHz; n20-mode [MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	74.503	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

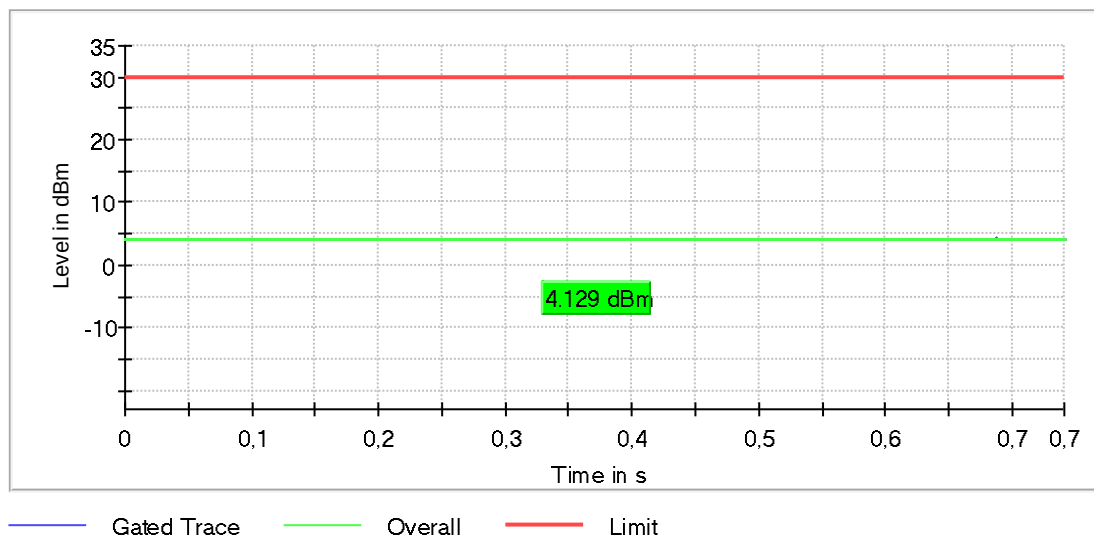
RF output power (5825 MHz; n20-mode [MCS4] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.1	30.0	4.1	74.389	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

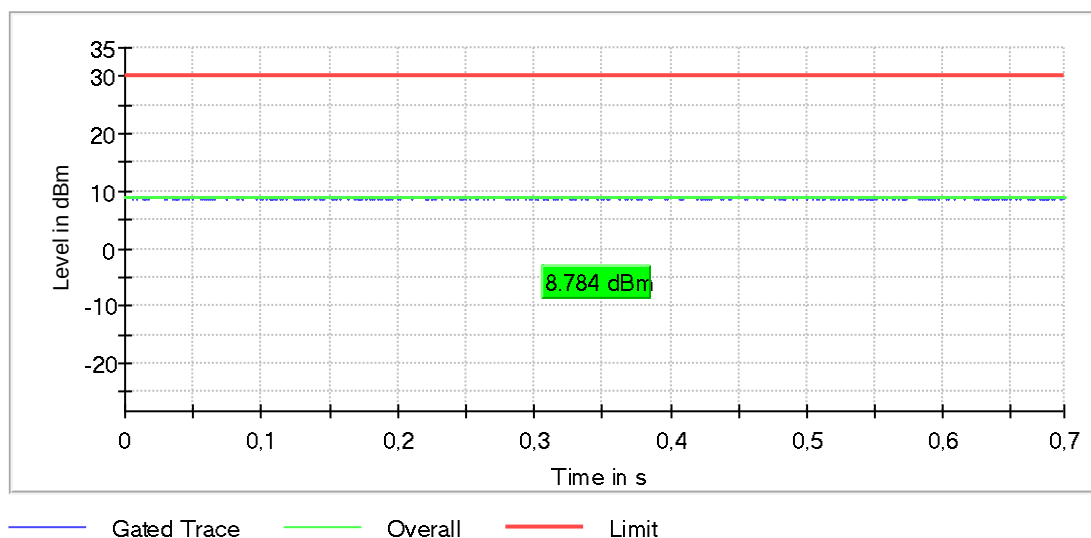
RF output power (5180 MHz; n20-mode [MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.8	30.0	8.8	69.186	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

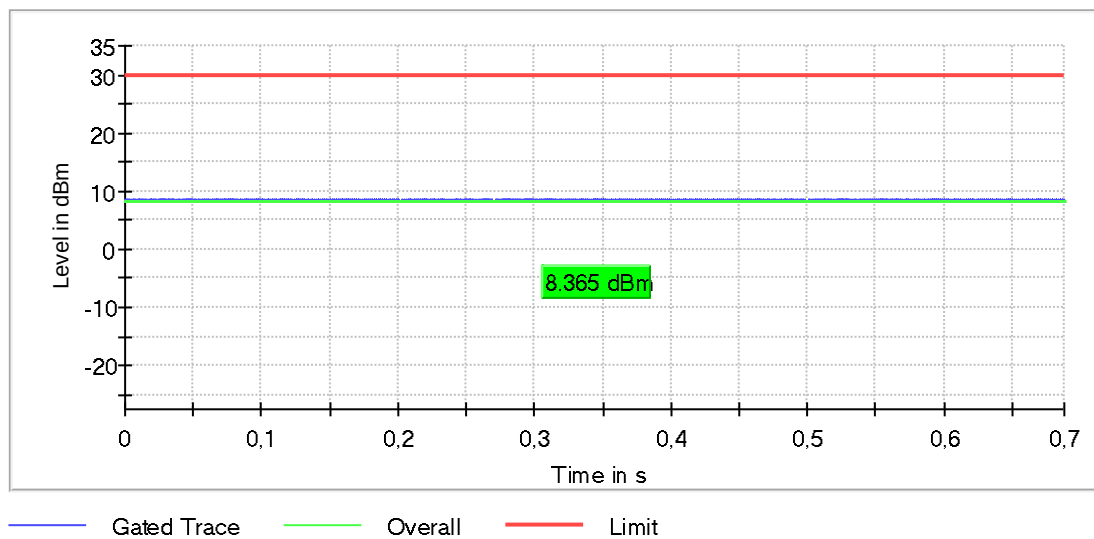
RF output power (5200 MHz; n20-mode [MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.4	30.0	8.4	69.100	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

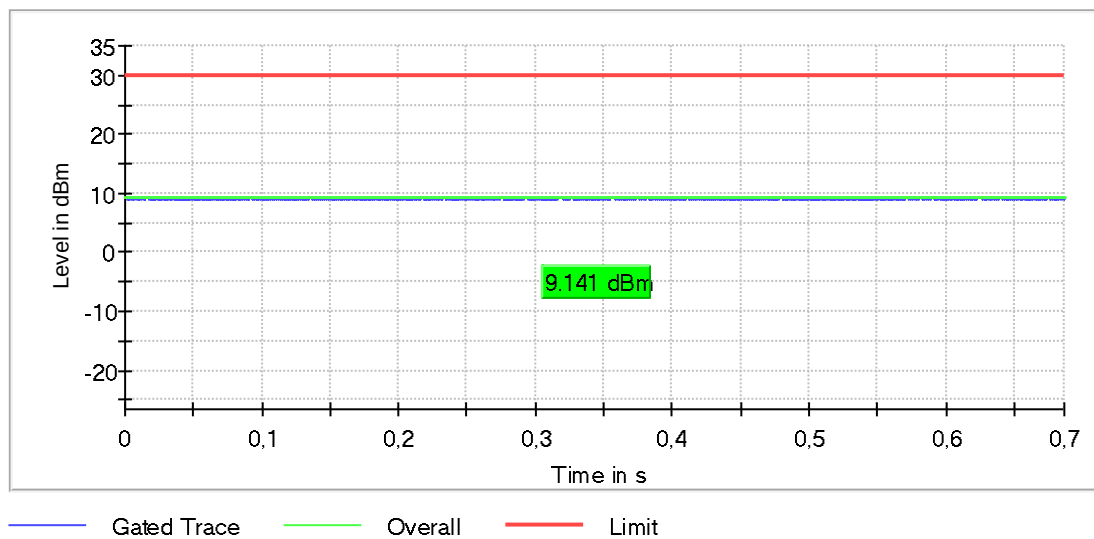
RF output power (5240 MHz; n20-mode [MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.1	30.0	9.1	68.931	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

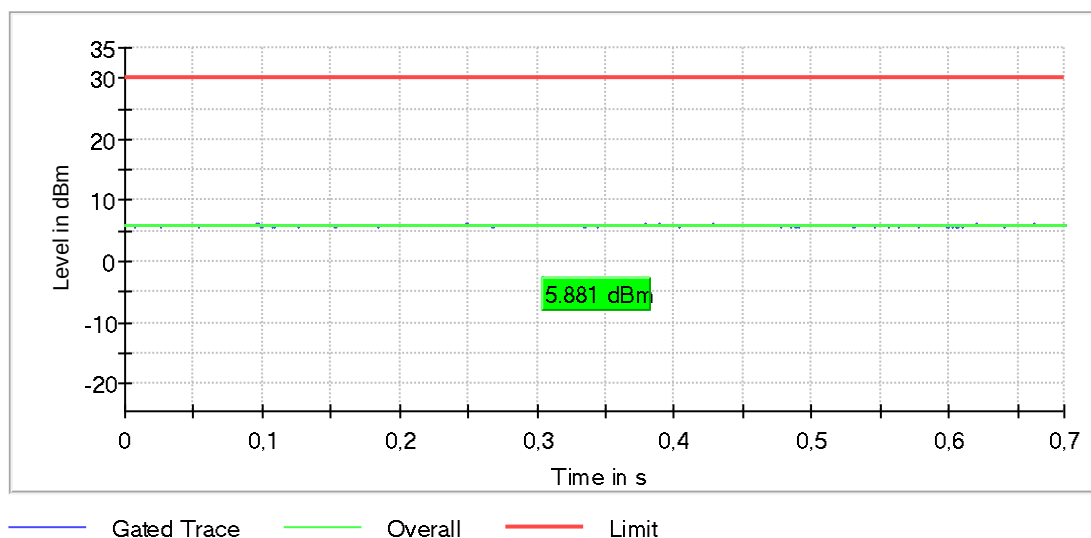
RF output power (5745 MHz; n20-mode [MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	5.9	30.0	5.9	68.687	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

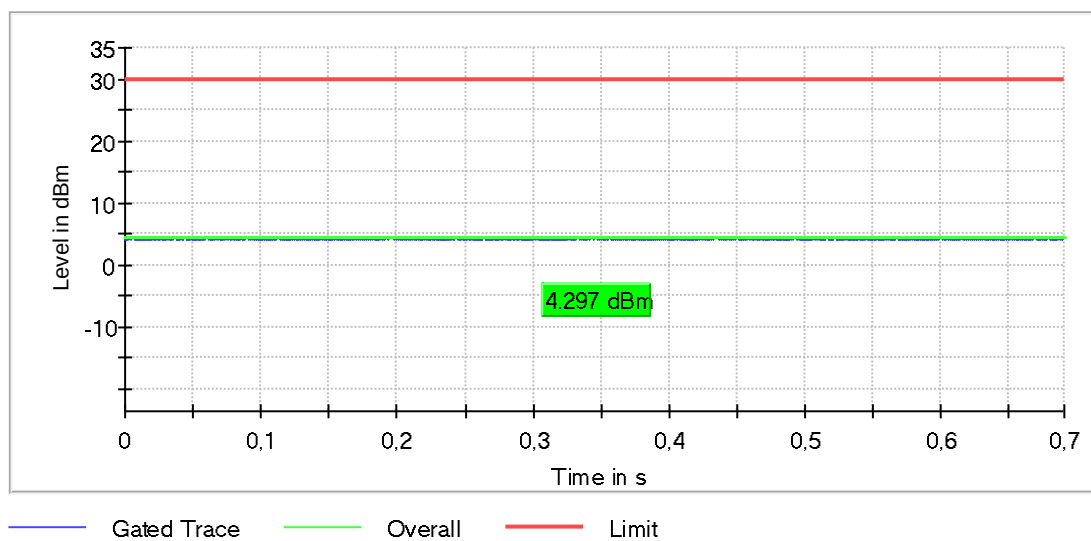
RF output power (5785 MHz; n20-mode [MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	69.314	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

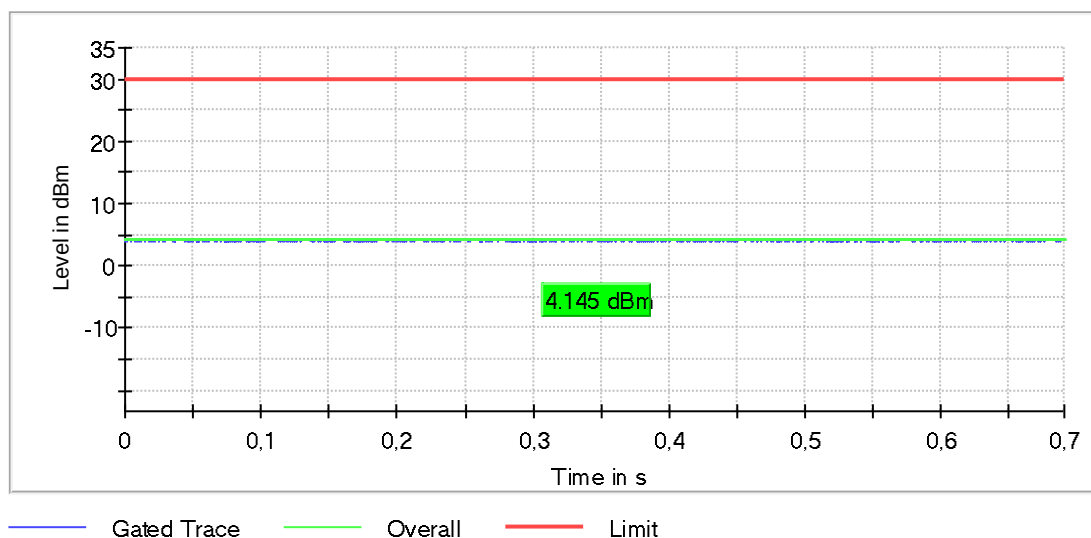
RF output power (5825 MHz; n20-mode [MCS5] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.1	30.0	4.1	69.321	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

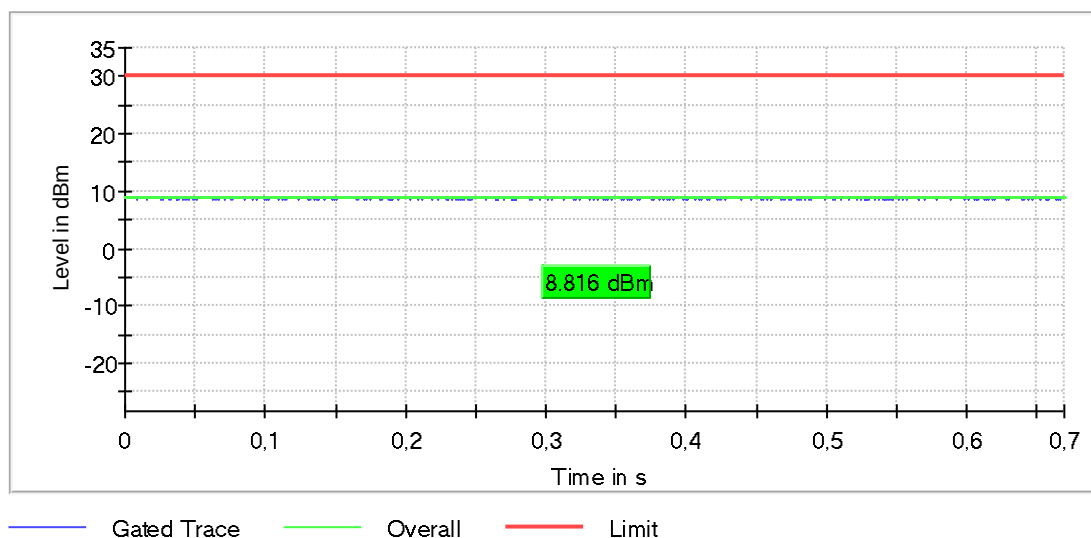
RF output power (5180 MHz; n20-mode [MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.8	30.0	8.8	67.252	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

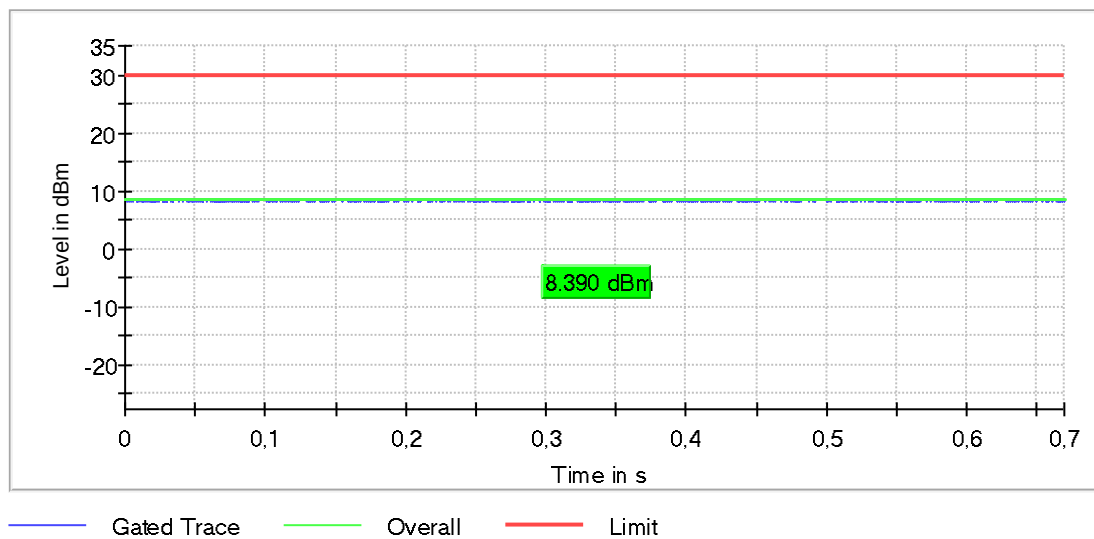
RF output power (5200 MHz; n20-mode [MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.4	30.0	8.4	67.246	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

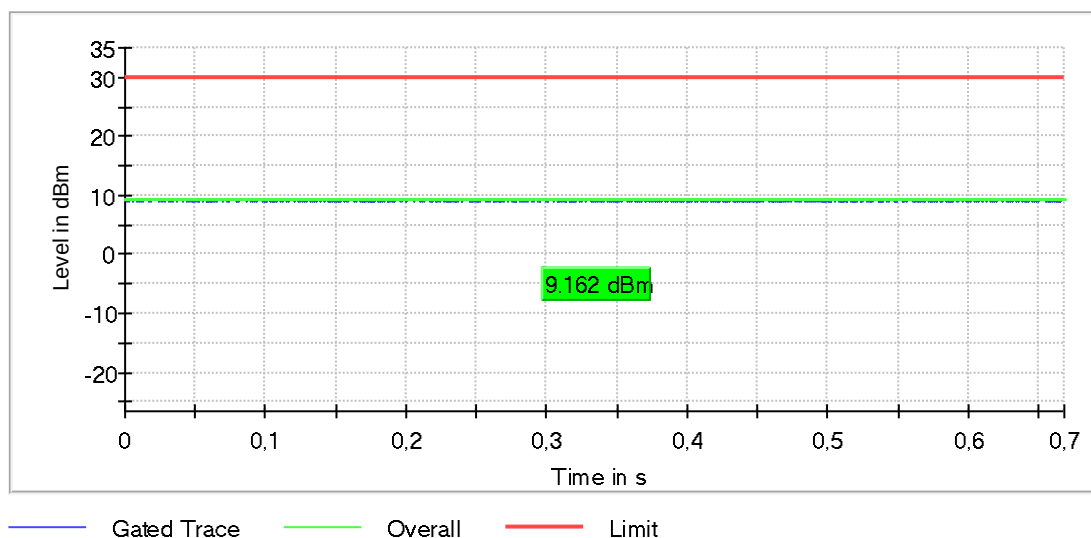
RF output power (5240 MHz; n20-mode [MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.2	30.0	9.2	67.092	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

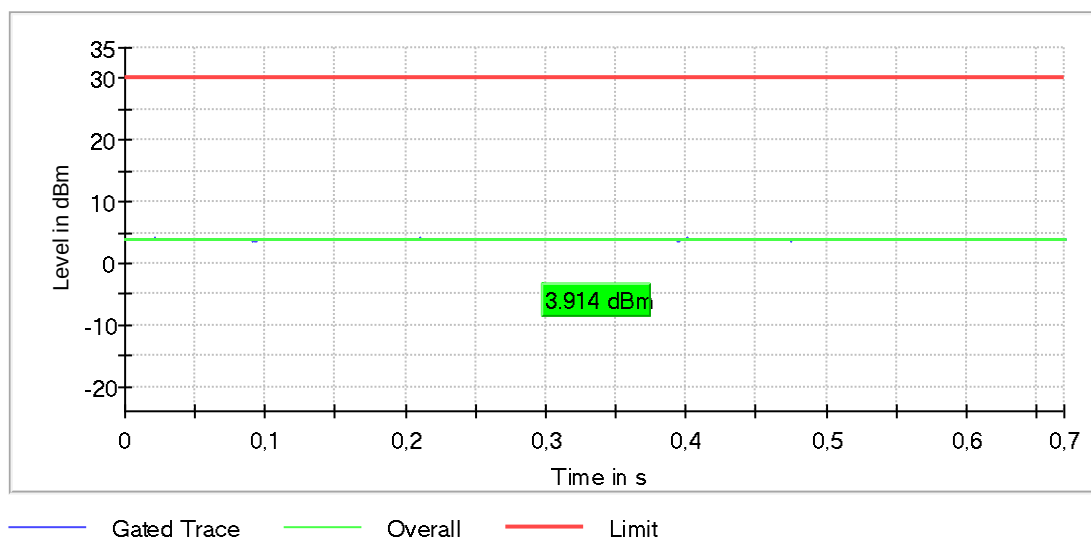
RF output power (5745 MHz; n20-mode [MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.9	30.0	3.9	67.285	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

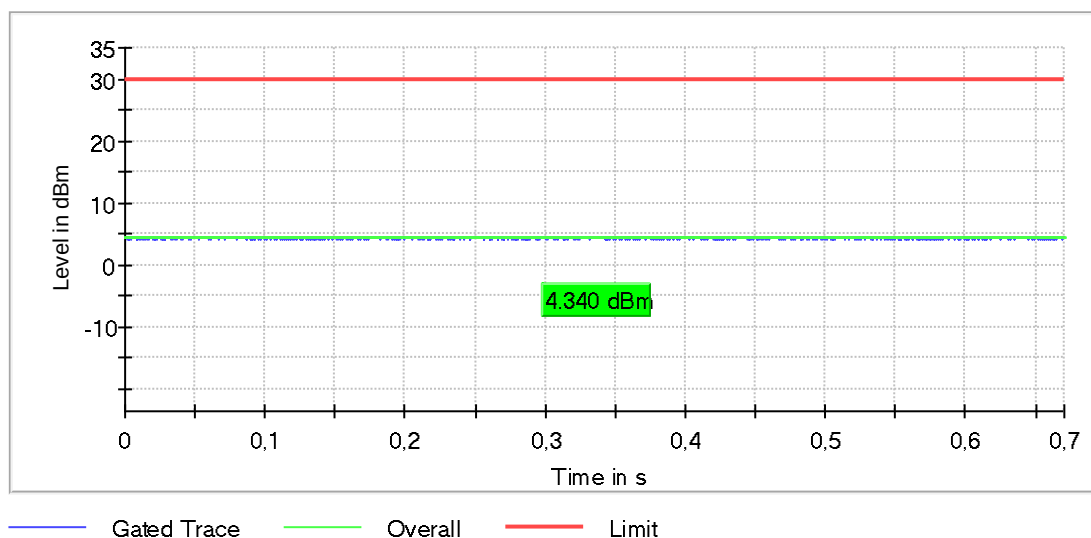
RF output power (5785 MHz; n20-mode [MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	67.338	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

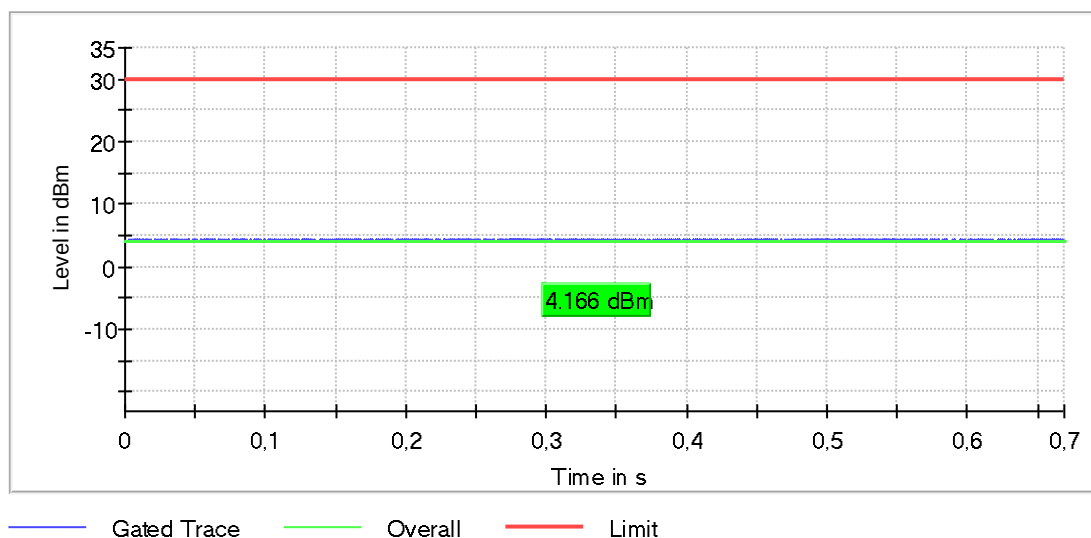
RF output power (5825 MHz; n20-mode [MCS6] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.2	30.0	4.2	67.207	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

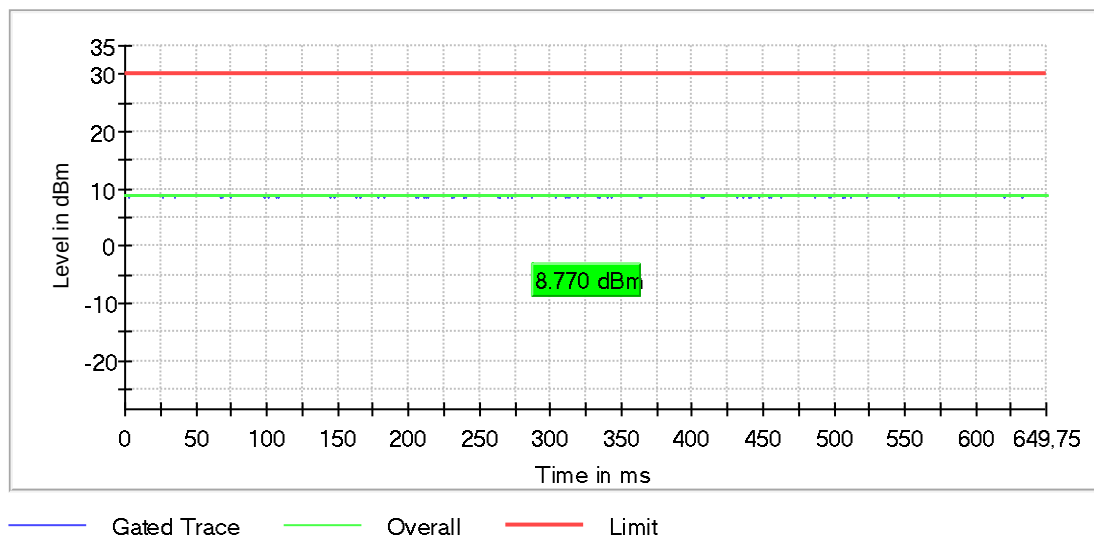
RF output power (5180 MHz; n20-mode [MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5180.000000	8.8	30.0	8.8	65.281	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

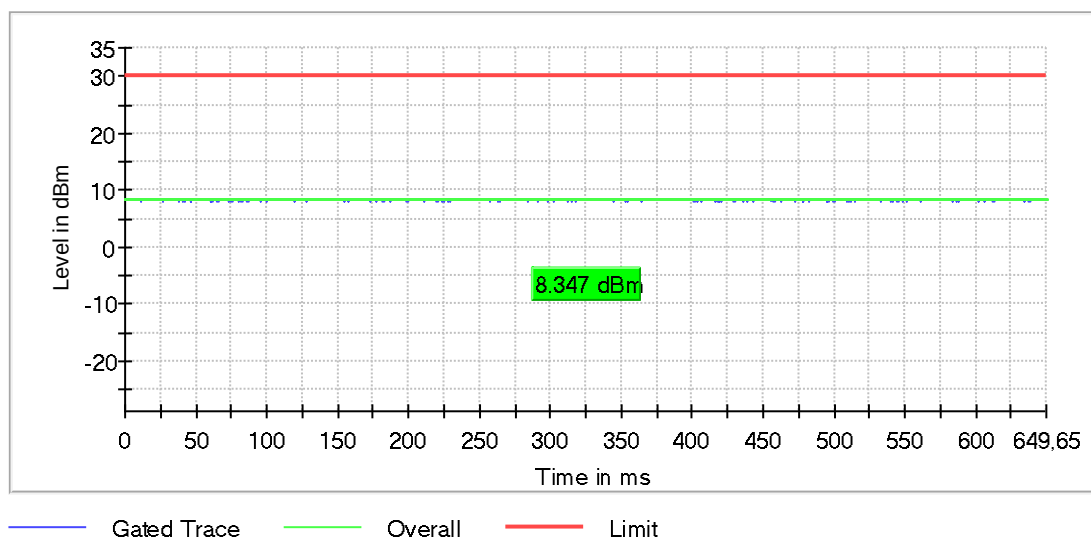
RF output power (5200 MHz; n20-mode [MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5200.000000	8.3	30.0	8.3	65.282	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

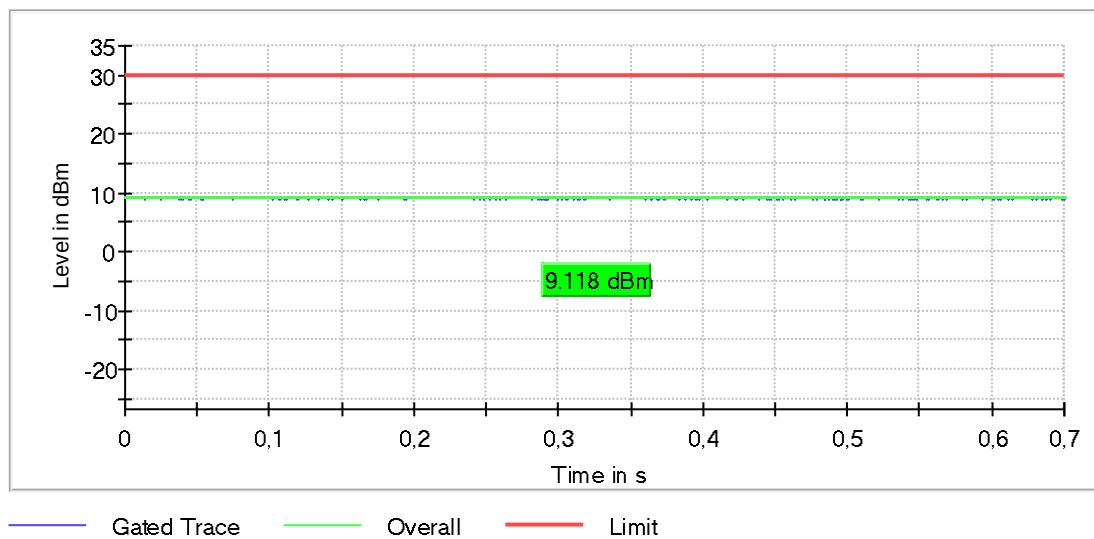
RF output power (5240 MHz; n20-mode [MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5240.000000	9.1	30.0	9.1	65.324	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

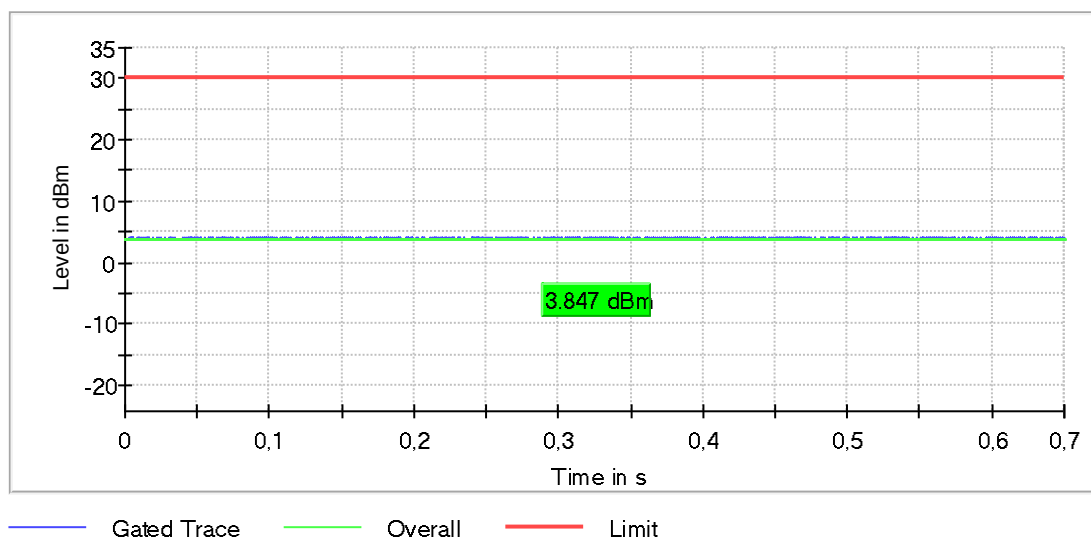
RF output power (5745 MHz; n20-mode [MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5745.000000	3.8	30.0	3.8	65.352	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

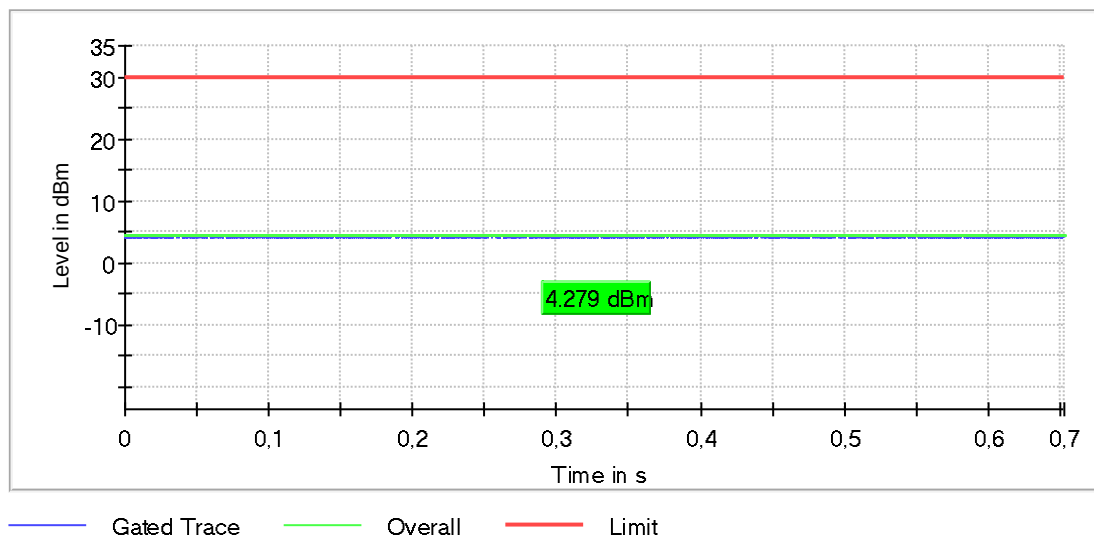
RF output power (5785 MHz; n20-mode [MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5785.000000	4.3	30.0	4.3	65.606	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s

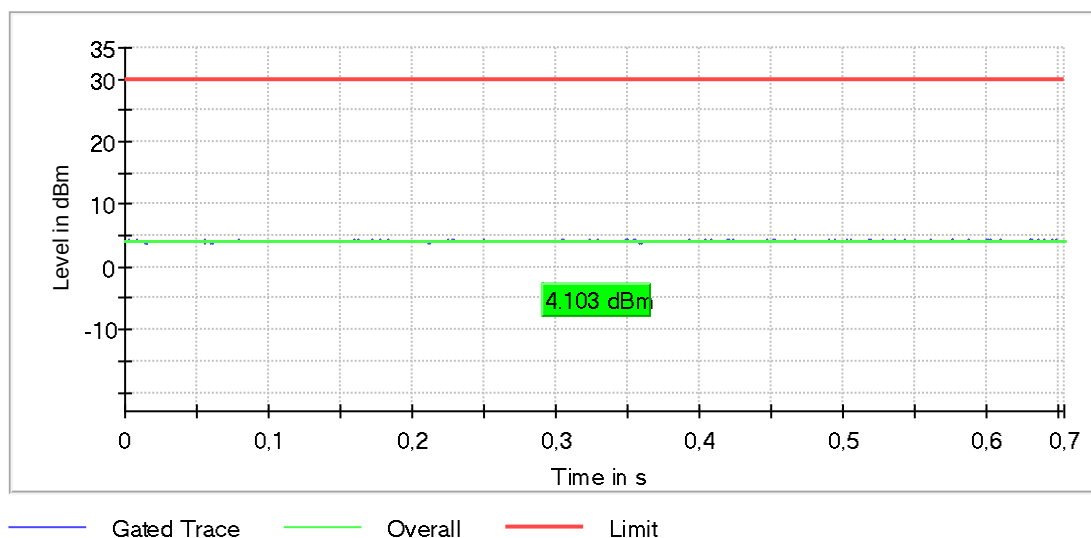
RF output power (5825 MHz; n20-mode [MCS7] (20 dBm); 20 MHz)

Test according to FCC title 47 part 15 §15.407(a), KDB 789033 D02 General U-NII Test Procedures New Rules v02r01 II.E and ANSI C63.10-2013

Result

DUT Frequency (MHz)	Gated RMS (dBm)	Limit Max (dBm)	Gated EIRP (dBm)	DutyCycle (%)	Result
5825.000000	4.1	30.0	4.1	65.714	PASS

Gated Trace



OSP PowerMeter settings

Setting	Instrument Value	Target Value
Measurement Time	1.000 s	1.000 s
Points	1000000	1000000
Time resolution	1.000 μ s	1.000 μ s